

## **POWER QUALITY ANALYZER PW3198**

Power Measuring Instruments





Record and Analyze Power Supply Problems Simultaneously with a Single Unit

# The New World Standard for Power Quality Analysis

#### Never Miss the Moment

- Detect power supply problems and perform onsite troubleshooting
- Do preventive maintenance to avert accidents by managing the power quality

### **CAT IV-600V Safety Standard**

- Meets the CAT IV safety rating required to check an incoming power line
- Safe enough to measure up to 6,000Vpeak of transient overvoltage

### **Easy Setup** Function with PRESETS

- Just select the measurement course, wiring, and clamps
- Automatic one-step setup based on measurement conditions

#### Compliant with New International Standards

- International power quality measurement standard IEC 61000-4-30 Edition 2 Class A
- High precision with a basic voltage measurement accuracy of 0.1%









ISO 9001 ISO14001 HIOKI company overview, new products, environmen and other information are available on our website



The number of power supply problems is increasing as power systems are becoming more and more complicated - all due to the rising use of power electronics devices plus a growing installed base of large systems and distributed power supplies. The quickest way to approach these problems is to understand the situation quickly and accurately. The PW3198 Power Quality Analyzer is ready to effectively solve your power supply problems.

## **Troubleshooting**

- ✓ Understand the actual power situation at the site where the problem is occurring (e.g., the equipment malfunction, failure, reset, overheating, or burning damage).
- ✓ Ideal for troubleshooting solar and wind power generation systems, EV charge stations, smart grids, tooling machines, OA equipment (e.g., computers, printers, and UPS), medical equipment, server rooms, and electrical equipment (e.g., transformers and phase-advancing capacitors).

## Field Survey and Preventive Maintenance

- ✓ Perform long-term measurements of the power quality and study problems that are difficult to detect or that occur intermittently.
- Maintain electrical equipment and check the operation of solar and wind power generation systems.
- Manage the parameters with a control set point, such as a voltage fluctuation, flicker, and harmonic voltage.

## Power (Load) Survey

Study the power consumption and confirm system capacity before adding load.

## Advanced Features for Safe, Simple, and Accurate Measurements

#### International Standard IEC61000-4-30 Edition 2 Class A

Class A is defined in the international standard IEC61000-4-30, which specifies compatibility with power quality parameters, accuracy, and standards to enable comparison and discussion of the measurement results of different measuring instruments.

The PW3198 is compliant with the latest IEC61000-4-30 Edition 2 Class A standard. The instrument can perform measurements in accordance with the standard, including continuous gapless calculation, methods to detect events such as dip, swell, and instantaneous power failure, and time synchronization using the optional GPS box.

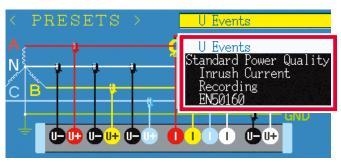


### CAT IV-600V Safety

The PW3198 is compliant with the measurement category CAT IV - 600V and can also safely test the incoming lines for both single-phase and three-phase power supplies.



### Easy to set up - Just select the measurement course and the PW3198 will do the rest



Simply choose the course based on the measurement objective and the necessary configurations will be set automatically.

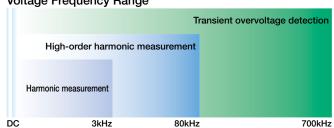
U Events	Record voltage and frequency and detect errors simultaneously.	
Standard Power Quality	Record voltage, current, frequency, and harmonic, and detect errors simultaneously.	
Inrush current	Measure the inrush current.	
Recording	Record only the TIME PLOT Data but do not detect errors.	
EN50160	Perform measurements in accordance with EN50160.	

#### Highly Accurate, Broadband, Wide Dynamic Range Makes for Reliable Measurements

## Voltage Measurement Range Transient overvoltage Line-to-line voltage (3P4W) Line-to-line voltage (1P2W, 1P3W, 3P3W) Phase voltage (1P2W, 1P3W, 3P4W) 1300V

Both low and high voltages can be measured in a single range.

#### Voltage Frequency Range



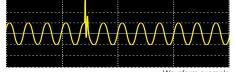
Wide range from DC voltage to 700 kHz

#### Basic Measurement Accuracy (50/60 Hz)

Voltage	±0.1% of nominal voltage
Current	±0.2% rdg. ±0.1% f.s. + Clamp-on sensor accuracy
Power	±0.2% rdg. ±0.1% f.s. + Clamp-on sensor accuracy

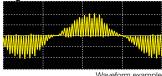
World's highest level of basic measurement accuracy. Extremely accurate voltage measurement without the need to switch ranges.

## Transient Overvoltage



Transient overvoltage can also be measured in a range between the maximum 6,000 V and minimum 1 µs (2 MS/s).

#### High-order Harmonic



The PW3198 is the first power quality analyzer that can measure the high-order harmonic component of up to 80 kHz.



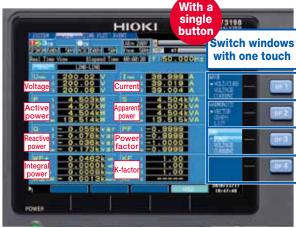
## PW3198 Never Misses the Moment a Power Supply Failure Occurs

The PW3198 can measure all waveforms of power, harmonic, and error events simultaneously. When a problem occurs with the equipment or system on your site, the PW3198 will help you detect the cause of the problem early and solve it quickly. You can depend on the PW3198 to monitor all aspects of your power supplies.

## Measure All Parameters at the Same Time

#### Acquire the Information You Need Quickly by Switching Pages (RMS Value)

Just connect to the measurement line, and the PW3198 will simultaneously measure all parameters, such as power and harmonic. You can then switch pages to view the needed information immediately.



#### **DMM Display**

Display parameters such as voltage, current, power, power factor, and integral power in a single window.

witch window



#### Waveform Display

Display the voltage and current waveforms on channels 1 to 4 one above the other in a single window.



4-channel Waveform Display

Display the voltage and current waveforms on channels 1 to 4 individually.



with one touch

#### Vector Display

Display the measured value and vector of the voltage and current of each order harmonic.

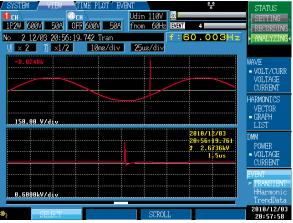


Harmonic Bar Graph Display

Display the RMS value and phase angle of harmonics from the 0th order to the 50th either in a graph or as numerical values.

#### Reliably Detect Power Supply Failures (Event)

To detect power supply failures, measurement does not need to be performed multiple times under different conditions. The PW3198 can always monitor and reliably detect all power supply failures for which detection is enabled.

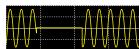


#### Transient Overvoltage (Impulse)

A transient overvoltage is generated by a lightning strike or a contact fault or closed contact of a circuit breaker and relay, and often causes a steep voltage change and a high voltage peak.

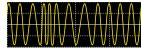
#### Voltage Dip (Voltage Drop)

Voltage drops for a short time as a result of large inrush current generated in the load by, for example, a starting motor.



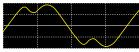
#### Interruption

The power supply stops instantaneously or for a short or long time because electrical power transmission is stopped as a result of a lightning strike, or because the circuit breaker is tripped by a power supply short circuit.



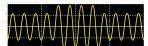
#### Frequency Fluctuations

An excessive increase or decrease of the load causes the operation of a generator to become unstable, resulting in frequency fluctuations.



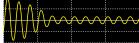
#### Harmonic

Harmonic is generated by a semiconductor control device installed in the power supply of equipment, causing distortion of voltage and current waveforms.



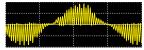
### Voltage Swell (Voltage Rise)

A voltage swell is generated by a lightning strike or a heavily loaded power line being opened or closed, causing the voltage to rise instantaneously.



#### Inrush Current

A large current flows instantaneously at the moment electrical equipment, a motor, or similar devices are powered on.



#### High-order Harmonic

Voltage and current waveforms are distorted by noise components generated by a semiconductor control device or the like installed in the power supply of electronic equipment.



#### Unbalance

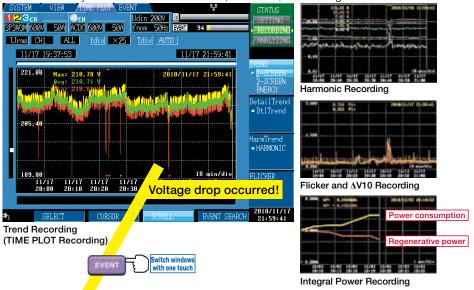
An increase or decrease in the load connected to each phase of the three-phase power supply or an unbalanced operation of equipment and devices causes the load of a particular phase to become heavy so that voltage and current waveforms are distorted, voltage drops, or negative phase sequence voltage is generated.

# Simultaneous Recording of TIME PLOT Data and Event Waveforms

### TIME PLOT Data

### TIME PLOT Recording of All Parameters

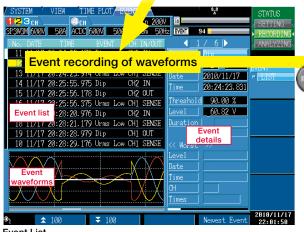
The PW3198 can simultaneously record 8,000 or more parameters, such as voltage, current, power, power factor, frequency, integral power, harmonic, and flicker, at the specified recording interval. The PW3198 never fails to capture the peak because it performs calculations continuously and records the maximum, minimum, and average values within the recording interval.



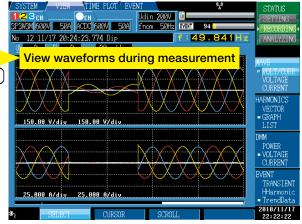
## **Event Waveforms**

## Capture up to 55,000 Instantaneous Waveforms of Power Supply Failures

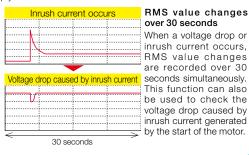
The PW3198 can record up to 1,000 instantaneous waveforms of power supply failures (up to 55,000 when repeat recording is set to ON) while performing TIME PLOT recording.



This list records instantaneous waveforms of power supply failures (events), such as a voltage drop or inrush current, along with the time or other information. Events are always monitored, regardless of the recording interval of the TIME PLOT recording.



The PW3198 lets you view the instantaneous waveform (200 ms) of a power supply failure in the window.

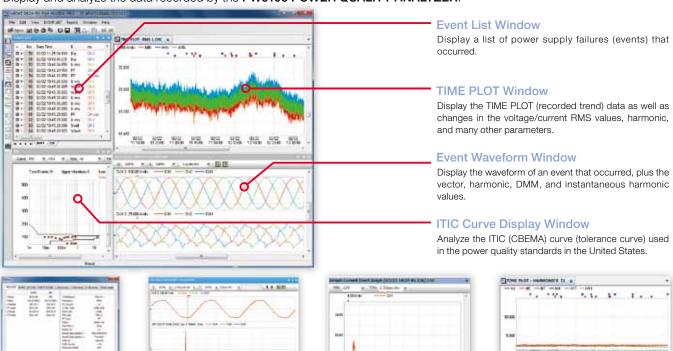


## Analyze Recorded Data with a PC Using Application Software 9624-50 PQA-HiVIEW PRO

Use Model 9624-50 PQA-HiVIEW PRO (version 2.00 or later) with a PC to analyze the data collected by the PW3198.

#### **Viewer Function**

Display and analyze the data recorded by the PW3198 POWER QUALITY ANALYZER.

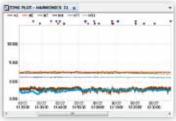


Status Window

**Transient Waveform Window** 

10 10 100

Inrush Current Event Graph Window



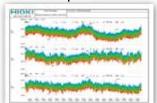
Harmonics TIME PLOT Window

### **Report Creation Function**

Automatically and effortlessly create rich reports for compliance and record management.

Voltage/current RMS value fluctuation graph, harmonic fluctuation graph, inter-harmonics fluctuation graph, flicker graph, integral power graph, demand graph, total harmonic voltage/current distortion rate list, EN50160 window (Overview, Harmonic, Measurement Results Category), worst case, transient waveform maximum/minimum value list, all event waveforms/detailed list, and setup list

#### **Print Examples**



**RMS Value Voltage Fluctuations** 



All Event Detailed List



TIME PLOT Recording of Parameters



EN50160

#### **Other Functions**

#### **CSV Conversion of Measurement Data**

Convert data in the range specified in the TIME PLOT window into CSV format and then save for further processing. The 9624-50 can also convert event waveforms into CSV format. Open CSV data using any commercially available spreadsheet software for advanced data management and analysis.

#### Even Analyze Data Recorded with Models 3196 and 3197 PQAs

Data recorded with the HIOKI 3196 and 3197 Power Quality Analyzers can also be analyzed



### **Download Measurement Data via USB/LAN**

Data in the SD card inserted in the PW3198 can be downloaded to a PC via USB or LAN.

#### **EN50160 Display Function**

EN50160 is a power quality standard for the EU. In this mode, evaluate and analyze power quality in accordance with the standard. You can display the Overview, Harmonic, and Measurement Results Category windows.

#### 9624-50 Specifications

Delivery media	CD-R	
Operating environment	AT-compatible PC	
	Windows XP, Windows Vista (32-bit), Windows 7 (32/64-bit)	
Memory	512 MB or more	

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## Useful Functions for a Wide Variety of Applications

#### Large Capacity Recording with SD Card

Data is recorded to a large capacity SD card. The data can be transferred to a PC and analyzed using dedicated application software. If your PC is not equipped with an SD card slot, simply connect a USB cable between the PW3198 and the PC. The PC will then recognize the SD card as removable media.



Repeat record	Recording period	
OFF Max. 35 days Reference value: ALL DATA (all items recorded), repeat OFF, and TIME PLOT interval 1 minute or longer)		
ON	Max. 55 weeks (about 1 year) Reference value: ALL DATA (all items recorded), repeat recording ON (1 week x 55 times), and TIME PLOT interval 10 minutes or longer)	

### Remote Measurement Using HTTP Server Function

You can use any Internet browser to remotely operate the PW3198, plus download the data stored in the SD card using dedicated software (LAN access required).

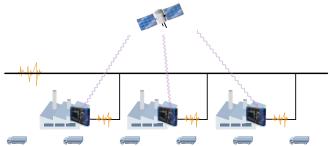


Conduct off-site remote control with a tablet PC using a wireless LAN router

### **GPS Time Synchronization**

The PW9005 GPS BOX lets you synchronize the clock on the PW3198 to the UTC standard time. Eliminate time differences between multiple PQAs and correctly analyze measurement data taken by several instruments.





#### Simultaneously Measure Three-phase Lines and Grounding Wire

Apart from the main measurement line, you can also measure the AC/DC voltage on another line using Channel 4.

#### Yes! Simultaneously!

- Measure the primary and secondary sides of UPS
- •Two-line voltage analysis
- •Measure three-phase lines and grounding wire
- Measure neutral lines to detect short circuits
- Measure the input and output of a DC-AC converter for solar power generation



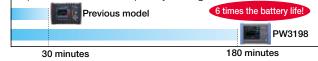
#### An Assortment of Clamp-on Sensors Covers a Broad Range of Measurements

In addition to current sensors for measuring 100A AC, 500A AC, 1000A AC and 5000A AC rated currents, a 5A AC sensor is also available. In addition, HIOKI's CLAMP ON LEAK SENSORS enable you to accurately measure for leakage current down to the mA level, while the new CT969X-90 AC/DC Clamp On Sensors further widen applications by supporting DC current testing.



#### **Backup and Recovery from Power Failure**

The PW3198 uses the new large capacity BATTERY PACK Z1003, enabling continuous measurement for three hours even if a power failure occurs. In addition, a power failure processing function restarts measurement automatically even if the power is cut off completely during measurement.



### **Other Measurement Applications**

#### Flicker measurement

Measure flicker in conformance with IEC 61000-4-15 Ed2. Phase voltage check for  $\Delta$  connection

Use the  $\Delta$ -Y and Y- $\Delta$  conversion function to measure phase voltage using a virtual neutral point.

### 400 Hz line measurement

Measure at a power line frequency of  $50/60~\mathrm{Hz}$  as well as  $400~\mathrm{Hz}$ .

## **Power Quality Survey Applications**

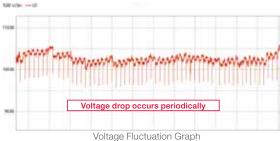
#### The power supply of the office equipment sometimes shuts down

Survey Objective
The power supply of a printer at the office shuts down even though it is not operated. Equipment other than the printer can also sometimes perform a reset unexpectedly.

#### easurement Method

Setup is very easy. Just install the PW3198 on the site, and measure the voltage, current, and power. To troubleshoot, just select the clamp-on sensor and wiring, and then select the





Analysis Report

No failure occurred during the measurement period, but a periodic voltage drop was confirmed. The voltage drop may have been caused by the periodic start and operation of the electrical equipment connected to the power supply line. Equipment, such as a laser printer, copier, and electrical heater, may start themselves periodically due to residual heat. An instantaneous voltage drop is likely to have been caused by inrush current from equipment that consumes a large amount of power.

### Medical equipment malfunctions

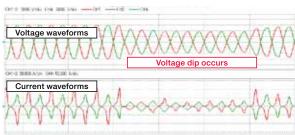
**Survey Objective**Replacing the equipment with a new one by the service provider did not improve the malfunction. A survey of the power supply was required to clarify the cause.

#### easurement Method

Select the "U Events" course in the PW3198 in the same way as with the office equipment example.







Voltage and Current Waveforms at the Time Voltage Dip Occurs

Analysis Report
It was determined that a voltage dip (voltage drop) occurred and impacted the operation of the equipment. If a voltage dip occurs every day on a regular basis, the probable cause is the start of a large air-conditioning unit, pump, heater, or similar equipment.

#### Surveying a Solar Power Generation System

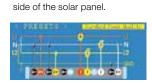
## Survey Objective

- · Maintain a solar power generation system and check its operation (verify the power quality)
- Troubleshoot (impact on the peripheral equipment, operation shutdown, etc.)

#### easurement Method

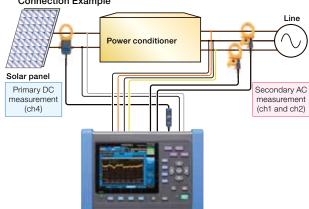
Set up the PW3198 on the site and measure the voltage, current, and power. To survey the power quality, select the "Standard power quality measurement" course in the PRESETS menu. To

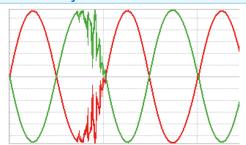
measure the DC voltage, connect channel 4 to the primary



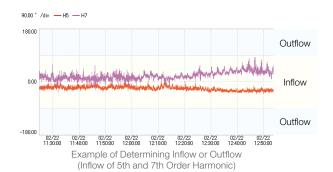


Connection Example





Example of Voltage Waveforms at the Time of Line Switching



Analysis Report

All parameters can be recorded simultaneously with a single measurement.

- Identify changes in the output voltage of the power conditioner
- Presence or absence of the occurrence of a transient overvoltage
- Frequency fluctuation important for system interconnection
- Identify changes in the harmonic voltage and current included in the output
- Power (AC), integral power (AC), etc.

## PW3198 Specifications (Accuracy guaranteed for one year)

Voltage	RMS voltage	Waveform voltage peak			
measurement items	Frequency	Frequency (1 cycle, 10-sec)			
(TIME PLOT Recording)	DC voltage	IEC Flicker (Pst, Plt)			
	Harmonic voltage (0 to 50th order)	Harmonic voltage phase angle (0 to 50th)			
	Inter-harmonic voltage (0.5 to 49.5th) Total harmonic voltage distortion factor	High order harmonic voltage component Voltage Unbalance factor			
	Total narmonic voltage distortion factor	(Zero-phase /Negative-phase)			
Current	RMS current	High order harmonic current component			
neasurement items	Waveform current peak	Total harmonic current distortion factor			
TIME PLOT Recording)	Harmonic current phase angle (0 to 50t	n) Current Unbalance factor			
	Harmonic current (0 to 50th)	(Zero-phase /Negative-phase)			
	Inter-harmonic current (0.5 to 49.5th)	K factor			
		DC current (when using compatible sensor)			
Power measurement items	Active power Reactive power	Harmonic power (0 to 50th) Harmonic voltage-current phase angle (0 to 50th)			
(TIME PLOT Recording)	Apparent power	Active energy			
(Tilvie i Eo i Necorality)	Power factor	Reactive energy			
EVENT	Transient overvoltage	Frequency fluctuations			
measurement items	Voltage swell	Voltage waveform comparison			
(EVENT Recording)	Voltage dip Timer				
	Interruption External events				
	Inrush current				
	thresholds available with other voltage, current and power measurement parameter, Inter-harmonic, Harmonic phase angle, IEC Flicker)				
Input specifications					
Measurement circuits	Single-phase 2-wire (1P2W), single-phase 3-wire (1P3W), three-phase 3-wire (3P3W2M, 3P4W2.5E) or three-phase 4-wire (3P4W) plus one extra input channel (must be synchronized to reference channel during AC/DC measurement)				
Fundamental frequency of measurement circuit	50Hz, 60Hz, 400Hz				
Input channels	Voltage: 4 channels (U1 to U4), Current: 4 channels (I1 to I4)				
Input methods	, ,	hannels not isolated between U1, U2 and U3; channels isolated between U1 to U3 and U4)			
,	Current : Insulated clamp-on sensors (voltage output)				
Input resistance	Voltage : $4M\Omega \pm 80$ kΩ (differential inputs) Current : $100$ kΩ $\pm 10$ kΩ				
Compatible clamp sensors	Units with f.s.=0.5V output at rated current input (f.s.=0.5V recommended) Units with rate of 0.1mV/A, 1mV/A, 10mV/A, or 100mV/A				
Measurement ranges	Voltage measurement ranges				
(Ch1 to Ch4 can be configured	Voltage measurement items	Ranges			
the same way; only CH4 can be	Voltage measurement	600.00V			
configured separately)	Transient measurement	6.0000kV peak			
	PW3198 current ranges				
		ange setting (A)  Current sensor  Current range setting(A)			

Current sensor	Current rang	e setting (A)
9660	100.00	/ 50.000
9661	500.00	/ 50.000
9667 (500A) *Discontinued	500.00	/ 50.000
9667 (5kA) *Discontinued	5.0000k	/ 500.00
CT9667 (500A)	500.00	/ 50.000
CT9667 (5kA)	5.0000k	/ 500.00
9669	1.0000k	/ 100.00
9694	50.000	/ 5.0000
9695-02	50.000	/ 5.0000
9695-03	100.00	/ 10.000

Current sensor	Current rang	ge settirig(A)
CT9691 (10A)	10.000	/ 5.0000
CT9691 (100A)	100.00	/ 10.000
CT9692 (20A)	50.000*	/ 5.0000
CT9692 (200A)	500.00*	/ 50.000
CT9693 (200A)	500.00*	/ 50.000
CT9693 (2kA)	5.0000k*	/ 500.00
9657-10	5.0000	/ 500.00m
9675	5.0000	/ 500.00m
*The full scale for each conser is based on the specifications		

\*The full scale for each sensor is based on the specifications of the sensor in use, not the range setting on the PW3198.

PW3198	Power	ranges

(automatically configured based on current range)

Current range		Power range (W / VA / var)
5.0000	kA	3.0000M
1.0000	kA	600.00k
500.00	Α	300.00k
100.00	Α	60.000k

Current range		Power range (W / VA / var)
50.000	Α	30.000k
10.000	Α	6.0000k
5.0000	Α	3.0000k

Rasic	specifications
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basic specifications	
Maximum recording period	55 weeks (with repeated recording set to [1 Week], 55 iterations) 55 days (with repeated recording set to [1 Day], 55 iterations) 35 days (with repeated recording set to [OFF])
Maximum recordable events	55,000 events (with repeated recording on) 1000 events (with repeated recording off)
TIME PLOT data settings	TIME PLOT interval (MAX/MIN/AVG within each interval recorded) 1s, 3s, 15s, 30s, 1m, 5m, 10m, 15m, 30m, 1h, 2h, 150 cycle (at 50Hz), 180 cycle (at 60Hz), 1200 cycle (at 400Hz) Screen copy interval (screen shot at each interval saved to SD card) OFF, 5m, 10m, 30m, 1h, 2h Timer EVENT interval (200ms instantaneous waveform saved at each interval) OFF, 1m, 5m, 10m, 30m, 1h, 2h Time start and End OFF: Start recording manually ON: Start time and End time can be configured Repeated recording settings (maximum 55 iterations) OFF: Recording is not repeated 1Week: 55 weeks maximum in 1week segmentations 1Day: 55 days maximum in 1day segmentations Repeat time Daily Start time and End time can be configured when Repeated recording set to 1Day.
Recording items settings	Power (Small): Recording basic parameters P&Harm (Normal): Recording basic parameters and harmonics All Data (Full): Recording P&Harm items and inter-harmonics
Memory data capacity	Max. 32 GB with SD Card; only use of the HIOKI 2GB SD Memory Card Model Z4001 is guaranteed by HIOKI. Contact your HIOKI representative for special order larger capacity cards that offer the HIOKI guarantee.

PRESETS function	U Events : Record and monitor voltage elements and frequency, plus detect events  Standard Power Quality : Record and monitor voltage and current elements, frequency, and harmonics, plus detect events  Inrush Current : Measure inrush current (basic voltage measurement required)  Recording : Record only trend data, no event detection  EN50160 : Measure according to EN50160 standards		
Real-Time Clock function	Auto-calendar, leap-year correcting 24-hour clock		
Display Language	English, Simplified Chinese, Japanese		
Real-time clock accuracy	±0.3 s per day (with instrument on, 23°C±5°C (73°F±9°F)		
Power supply	AC ADAPTER Z1002 (12 VDC, Rated power supply 100VAC to 240VAC, 1.7Amax, 50/60Hz) BATTERY PACK Z1003 (Ni-MH 7.2VDC 4500 mAh)		
Maximum rated power	15VA (when not charging), 35VA (when charging)		
Continuous battery operation time	Approx. 180 min. [@23°C (@73.4°F), when using <b>BATTERY PACK Z1003</b> ]		
Recharge function	BATTERY PACK Z1003 charges regardless of whether the instrument is on or off; charge time: max. 5 hr. 30 min. @23°C (@73.4°F)		
Power outage processing	In the event of a power outage during recording, instrument resumes recording once the power is back on (integral power starts from 0).		
Power supply quality measurement method	IEC61000-4-30 Ed.2 :2008 IEEE1159 EN50160 (using Model <b>PQA-HiVIEW PRO 9624-50</b> )		
Dimensions	Approx. 300 W× 211 H × 68 D mm (11.81" W × 8.31" H × 2.68" D) (excluding protrusions)		
Mass	Approx. 2.6 kg (91.7 oz.) (including battery pack)		
Accessories	Instruction manual, Measurement guide, VOLTAGE CORD L1000 (8 cords, approx. 3 m each: 1 each red, yellow, blue, and gray plus 4 black; 8 alligator clips: 1 each red, yellow, blue, and gray plus 4 black), Spiral Tube, Input Cable Labels (for identifying channel of voltage cords and clamp-on sensors), AC ADAPTER Z1002, Strap, USB cable (1 m length), BATTERY PACK Z1003, SD MEMORY CARD (2GB) Z4001		
Display specifications			

1	Display	6.5-inch TFT color LCD (640 × 480 dots)

### **External Interface Specifications**

SD card Interface			, Saving and Loading screen copies			
	Slot	Slot : SD standard compliant				
	Compatible card	: SD memory card/ SDHe				
	Supported memory capacity	: Max. 32 GB with SD Card;	only use of the HIOKI 2GB SD Memory Card M	odel Z4001 is guaranteed by HIOKI.		
		Contact your HIOKI repres	entative for special order larger capacity card	ls that offer the HIOKI guarantee.		
	Media full processing	: Saving of data to SD me	emory card is stopped	_		
RS-232C Interface	Measurement and control u	ising GPS-synchronized tir	ne (connecting GPS BOX)			
	Connector	: D-sub9pin				
	Connection destination	: GPS box (cannot be co	nnected to computer)			
LAN Interface	1. HTTP server function (co	mpatible software: Interne	t Explorer Ver.6 or later, Remote operation	n application function,		
	measurement start and sto	op control functions, syste	m configuration function, event list func-	tion (capable of displaying eve		
	waveforms, event vectors, a	and event harmonic bar gra	aphs)			
	<ol><li>Downloading of data fror</li></ol>	n the SD memory card usir	ng the 9624-50 PQA-HiView Pro			
	Connector	: RJ-45				
	Transmission method	: 10BASE-T,100BASE-TX				
USB2.0 Interface	Recognizes the SD mem	Recognizes the SD memory card as a removable disk when connected to a computer.				
	The instrument cannot be d	The instrument cannot be connected during recording (including standby operation) or analysis.				
	2. Download data from the	2. Download data from the SD memory card using the 9624-50 PQA-HiView Pro				
	The instrument cannot be o	onnected during recording	(including standby operation) or analysis	S.		
	Connector	: Series B receptacle				
	Connection destination	: Computer [WindowsXP,	WindowsVista(32bit), Windows7 (32/64b	oit)]		
External control interface	Connector	: 4-pin screwless termina	al block			
	External event input		evel (at falling edge of 1.0 V or less and when shorted) be	tween GND terminal and EVENT IN terminal		
			s; rated voltage: -0.5 V to +6.0 V			
	External event output	·	,			
	· ·	External event output item setting		Pulse width		
		Short pulse output	TTL low output at event generation between [GND] terminal and [EVENT OUT] terminal	Low level for 10 ms or more		
		Long pulse output	TTL low output at event generation between [GND] terminal and [EVENT OUT] terminal (No external event output at START event)			
		ΔV10 alarm	TTL low output at ΔV10 alarm between [GND] terminal and [EVENT OUT] terminal	Low level while alarm occurring ; reverts to high at data reset		

### Environment and safety specifications

Operating environment	Indoors, altitude up to 3000 m (measurement category is lowered to 600 V CAT III when above 2000m), Pollution degree 2			
Storage temperature and humidity	-20 to 50°C (-4 to 122°F) 80% RH or less (non-condensating)			
	[If the instrument will not be used for an extended period of time, remove the battery pack and store in a cool location [from -20 to 30°C (-4 to 86°F)].]			
Operating temperature and humidity	0 to 50°C (32 to 122°F) 80% RH or less (non-condensating)			
Dust and water resistance	IP30 (EN60529)			
Maximum input voltage	Voltage input section 1000 VAC, DC±600 V, max. peak voltage ±6000 Vpeak			
	Current input section 3VAC, DC±4.24V			
Maximum rated voltage to earth	Voltage input terminal 600 V (Measurement Categories IV, anticipated transient overvoltage 8000 V)			
Dielectric strength	6.88 kVrms (@50/60 Hz, 1 mA sense current):			
	setween voltage measurement terminals (U1 to U3) and voltage measurement terminals (U4)			
	4.30 kVrms (1 mA@50/60 Hz, 1 mA sense current):			
	Between voltage input terminal (U1 to U3) and current input terminals/interfaces			
	Between voltage (U4) and current measurement terminals, and interfaces			
Applicable	Safety EN61010			
standards	EMC EN61326 Class A, EN61000-3-2,			
	EN61000-3-3			

**Measurement Specifications** (For specifications when measuring 400Hz circuits, please inquire with your HIOKI distributor.) **TIME PLOT**: The MAX/MIN/AVG of each recording interval for each parameter are recorded. **EVENT**: When a power anomaly occurs, approx. 200ms instantaneous waveform is recorded. **TRANSIENT**: When a transient overvoltage is detected, the 2ms instantaneous waveforms before and after the occurrence (total 4ms) are recorded. **FLUCTUATION**: The RMS fluctuation 0.5s before and 29.5s after an event has occurred are recorded. HIGH-ORDER HARM: : When a high order harmonic event occurs, the 40ms instantaneous waveform is recorded. Transient overvoltage Display items For single transient incidents and continuous transient incidents Transient voltage value, Transient width For continuous transient incidents Transient period (Period from transient IN to transient OUT) Max. transient voltage value (Max. peak value during the period) Transient count during period Detected from waveform obtained by eliminating the fundamental component (50/60/400 Hz) from the sampled waveform Measurement method Sampling frequency ±6.0000kVpeak, 0.0001kV Measurement range, resolution Measurement bandwidth 5 kHz (-3dB) to 700 kHz (-3dB) Min. detection width 0.5 µs

RMS outgase? RMS current referehed each half-cycle  RMS contraint reflected each half-cycle  RMS current reflected each half-cycle  RMS	±5.0% rdg.±1.0%f.s.
Measurement method   FMS voltage refreshed each hat cycle : True FMS tyne, RMS voltage volues are acculated using sample data for 1, weedform devided by covering print welform data samples of the 1, weedform devided by covering print welform data samples of each hat cycle : RMS current is acculated using current welform data samples of each hat cycle : PMS current services of the covering print welform data samples of each hat cycle : DMS voltage refreshed each hat cycle each each search in the regality director interruption : An external course in the regality of the cycle in the regality director interruption : DMS voltage refreshed each hat cycle each each hat cycle each each refreshed each hat cycle each each hat cycle each each hat cycle each each hat cycle each each each refreshed each hat cycle each each hat cycle each each each each each each each eac	refreshed each half-cycle TIME PLOT EVENT
August Production   Augu	
Sampling frequency   2006-tz	1 waveform derived by overlapping the voltage waveform every half-cycle
Measurement range, resolution  Miss voltage refreshed each half-cycle : 60.0.00 // .0.01V  Measurement accuracy  Measurement method  Display item  D	
RMS current effected each felf-cycle : Based on cleamp-on servacion in use; see Input pedicidations with Severage felf-cells and some input voltage of at least 100/; ±0.2% for John Servacion in use; see Input pedicidation in the County of t	
MS voltage refreshed each half-cycle   + 0.2% of normal voltage (MI) 128/8 is a 198/8 is a remain part obage of the 198/8 (A) 198/8 is a remain part obage of the 198/8 is 20.2% of 20.5% of 34.0% of 35.5% is a 198/8 is 198/8 is a remain part obage of the 198/8 is 198/8 is 198/8 is a remain part obage of the 198/8 is 198/8 is 198/8 is a remain part obage of the 198/8 is	
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Swell   Swel	
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Interruption : Interruption depth, Interruption duration   New Bull addected byte that he RMS voltage refreshed each half-cycle exceeds the threshold in the positive direction   Dip : A dip is detected when the RMS voltage refreshed each half-cycle exceeds the threshold in the positive direction   Turnsh current   Part Interruption : A mineruption is already voltage refreshed each half-cycle exceeds the threshold in the negative direction   Turnsh current   Part Interruption   Pa	Swell : Swell height, Swell duration
Swell   . A swell is detected when the RMS voltage refreshed each half-cycle exceeds the threshold in the positive direction interruption : An interruption is detected when the RMS voltage refreshed each half-cycle exceeds the threshold in the negative direction interruption : An interruption is detected when the RMS voltage refreshed each half-cycle exceeds the threshold in the negative direction interruption is detected when the RMS voltage refreshed each half-cycle exceeds the threshold in the negative direction.    Pange and accuracy	
Dip : A dip is detected when the RMS voltage refreshed each half-cycle exceeds the threshold in the negative direction interruption is an interruption is detected when the RMS voltage refreshed each half-cycle exceeds the threshold in the negative direction.  Trush current  Display Item  Maximum current of RMS current refreshed each 1/2 cycle  Measurement method  Detected when the RMS current refreshed each 1/2 cycle exceeds the threshold in a positive direction.  Range and accuracy  See RMS current refreshed each half-cycle  RMS voltage, RMS current  BMS voltage, RMS current  BMS voltage, RMS current  BMS voltage : RMS voltage is RMS voltage for each channel and AWG (average) RMS voltage for multiple channels  RMS current : RMS current for each channel and AWG (average) RMS current for multiple channels  RMS current : RMS current for each channel and AWG (average) RMS current for multiple channels  RMS current : RMS current for cach channel and AWG (average) RMS current for multiple channels  RMS current : RMS current for cach channel and AWG (average) RMS current for multiple channels  RMS current : RMS current refreshed each 1/2 cycles (60 Hz)  RMS voltage : 800.000, 0.01V  Measurement range, resolution  RMS voltage : 800.000, 0.01V  RMS voltage waveform peak / current waveform peak : \$100.000 colors of the second voltage voltage vol	
Inferruption : An interruption is detected when the RNS voltage refreshed each half-cycle exceeds the threshold in the negative director   Inrush current   I	
Flarings and accuracy   See RMS voltage refreshed each half-cycle   Inrush current   Inrush current   Maximum current of RMS current refreshed each 1/2 cycle exceeds the threshold in a positive direction   Beauty of the Company o	
Institute   Inst	
Display item   Maximum current of RMS current refreshed each 1/2 cycle	
Measurement method   Detected when the RMS current refreshed each 1/2 cycle exceeds the threshold in a positive direction	
Range and accuracy  See RMS current refreshed each half-cycle  RMS voltage, RMS current  RMS voltage; RMS voltage in RMS voltage for each channel and AVG (average) RMS voltage for multiple channels RMS current : RMS current for each channel and AVG (average) RMS current for multiple channels RMS current : RMS current for each channel and AVG (average) RMS current for multiple channels RMS current : RMS current for each channel and AVG (average) RMS current for multiple channels RMS current : RMS current TD cvalues with release of new clamp- on sensor) RMS value calculated from 10 cycles (50 Hz) or 12 cycles (60 Hz)  Sampling frequency  200kHz  Measurement range, resolution RMS voltage : 600.00V, 0.01V RMS current : Based on clamp-on sensor in use: see input specifications RMS current : 80.2% rogs.xt.1% for hominal voltage (With 1.668% fs. to 110% fs. or a nominal input voltage of late at 100 V) RMS current : x0.2% rogs.xt.1% fs. x-clamp-on sensor accuracy  Voltage waveform peak/ Current waveform peak  Measurement method  Measurement method  Measurement method  Measurement range, resolution  Woltage waveform peak is x120.00 Vpeak, 0.1V Current waveform peak : x120.00 Vpeak, 0.1V Current wavef	·
RMS voltage, RMS current   FIME PLOT   EVENT	, ,
Display Items RMS voltage : RMS voltage for each channel and AVG (average) RMS voltage for multiple channels RMS current for RMS current for each channel and AVG (average) RMS current for multiple channels RMS current for seach channel and AVG (average) RMS current for multiple channels RMS current for multiple channels RMS current for each channel and AVG (average) RMS current for multiple channels RMS current is RMS current in the control of the current RMS current in the control of RMS current in the control of RMS current in Based on calemo-on sensor in use; see Input specifications  Measurement accuracy RMS current in Based on calemo-on sensor in use; see Input specifications  Measurement accuracy RMS voltage in 40.2% rdg ±0.08% fs. (With input outside the range of 166% fs. to 110% fs. input and a nominal input voltage of at least 100 V) RMS current in ±0.2% rdg ±0.08% fs. (With input outside the range of 166% fs. to 110% fs. or a nominal input voltage of its shan 100 V) RMS current in ±0.2% rdg ±0.08% fs. (With input outside the range of 166% fs. to 110% fs. input and a nominal input voltage of its shan 100 V) RMS current in ±0.2% rdg ±0.08% fs. (With input outside the range of 166% fs. to 110% fs. input and a nominal input voltage of its shan 100 V) RMS current in ±0.2% rdg ±0.08% fs. (With input outside the range of 166% fs. to 110% fs. input and a nominal input voltage of its shan 100 V) RMS current voltage fs. (With input outside the range of 166% fs. to 110% fs. input and a nominal input voltage of its shan 100 V) RMS current voltage of its shan 100 V) RMS current voltage voltag	
RMS current : RMS current for each channel and AVG (average) RMS current for multiple channels   RAP-DC Truer RMS type (Current DC value: with release of new clamp-on sensor)   RMS value calculated from 10 cycles (50 Hz) or 12 cycles (60 Hz)   RMS value calculated from 10 cycles (50 Hz) or 12 cycles (60 Hz)   RMS value calculated from 10 cycles (50 Hz) or 12 cycles (60 Hz)   RMS value calculated from 10 cycles (50 Hz) or 12 cycles (60 Hz)   RMS value calculated from 10 cycles (50 Hz) or 12 cycles (60 Hz)   RMS current : Based on clamp-on sensor in use; see linput specifications   RMS values : ± 1.01% or forminal voltage (With 1.666% f.s. to 110% f.s. input and a nominal input voltage of at least 100 V)   RMS current : ± 0.28% rdg. ± 0.08% f.s. (With input outside the range of 1.666% f.s. to 110% f.s. or a nominal input voltage of less than 100 V)   RMS current : ± 0.28% rdg. ± 0.18% f.s. (With input outside the range of 1.666% f.s. to 110% f.s. or a nominal input voltage of less than 100 V)   RMS current : ± 0.28% rdg. ± 0.18% f.s. (With input outside the range of 1.666% f.s. to 110% f.s. or a nominal input voltage of less than 100 V)   RMS current : ± 0.28% rdg. ± 0.08% f.s. (With input outside the range of 1.666% f.s. to 110% f.s. or a nominal input voltage of less than 100 V)   RMS current waveform peak : ± 0.200 f.s. (With input outside the range of 1.666% f.s. to 110% f.s. (Input outside the range of 1.666% f.s. to 110% f.s. (Input outside the range of 1.666% f.s. to 110% f.s. (Input outside the range of 1.666% f.s. to 110% f.s. (Input outside the range of 1.666% f.s. to 110% f.s. (Input outside the range of 1.666% f.s. to 110% f.s. (Input outside the range of 1.666% f.s. to 110% f.s. (Input outside the range of 1.666% f.s. to 110% f.s. (Input outside the range of 1.666% f.s. to 110% f.s. (Input outside the range outside the range of 1.666% f.s. to 110% f.s. (Input outside the range of 1.666% f.s. to 110% f.s. (Input outside the range of 1.666% f.s. to 110% f.s. (Input outside the range of 1.666% f.s. to	
Measurement method   AC-DC True RMS type (Current DC value: with release of new clamp-on sensor) RMS value calculated from 10 cycles (50 Hz) or 12 cycles (60 Hz)	
RMS value calculated from 10 cycles (50 Hz) or 12 cycles (60 Hz)  Measurement range, resolution RMS values: 600.00V, 0.01V RMS current: Based on clamp-on sensor in use; see input specifications Reasurement accuracy RMS voltage: 1.01% of nominal voltage (With 1.666% f.s. to 110% f.s. input and a nominal input voltage of at least 100 V) ±0.2% rdg.±0.19% f.s. with input outside the range of 1.666% f.s. to 110% f.s. or a nominal input voltage of at least 100 V) RMS current: ±0.2% rdg.±0.19% f.s. + clamp-on sensor accuracy  Voltage waveform peak/ Current waveform peak Reasurement method Measurement method Measurement method Measurement range, resolution Voltage waveform peak: ±1200.0 Vpeak, 0.1V Current wavef	1 07
Measurement range, resolution RMS current: Based on clamp-on sensor in use; see Input specifications  Measurement accuracy RMS current: Based on clamp-on sensor in use; see Input specifications  RMS voltage: ±0.1% of nominal voltage (With 1.666% f.s. to 110% f.s. input and a nominal input voltage of at least 100 V) 20.2% rdg.±0.2% rdg.±0.08% f.s. (With input outside the range of 1.666% f.s. to 110% f.s. or a nominal input voltage of at least 100 V) RMS current: ±0.2% rdg.±0.1% f.s. + clamp-on sensor accuracy  Voltage waveform peak/ Current waveform peak  Display item Positive peak value and negative peak value  Measurement method Measurement method Measurement range, resolution Voltage waveform peak: ±1200.0 Vpeak, 0.1V Current waveform peak : ±1200.0 Vpeak, 0.1V Current waveform peak: ±1200.0 Vpeak, 0.1V Current waveform peak: ±1200.0 Vpeak, 0.1V Current waveform peak: ±1200.0 Vpeak, 0.1V Current waveform peak : ±1200.0 Vpeak, 0.1V Current waveform	
RMS current : Based on clamp-on sensor in use; see Input specifications   RMS voltage : ±0.1% of nominal voltage (With 1.666% f.s. to 110% f.s. input and a nominal input voltage of at least 100 V)   RMS voltage : ±0.1% of nominal voltage (With 1.666% f.s. to 110% f.s. input and a nominal input voltage of least 100 V)   RMS current : ±0.2% rdg.±0.1% f.s. + clamp-on sensor accuracy   RMS current : ±0.2% rdg.±0.1% f.s. + clamp-on sensor accuracy   RMS current : ±0.2% rdg.±0.1% f.s. + clamp-on sensor accuracy   RMS current   RMS current : ±0.2% rdg.±0.1% f.s. + clamp-on sensor accuracy   RMS current	200kHz
RMS voltage : ±0.1% of nominal voltage (With 1.666% f.s. to 110% f.s. input and a nominal input voltage of at least 100 V) ±0.2% rdg.±0.08% fs. [With put outside the range of 1.666% f.s. to 110% f.s. or a nominal input voltage of least 100 V) ±0.2% rdg.±0.1% fs., + clamp-on sensor accuracy	RMS voltage: 600.00V, 0.01V
# ±0.29krdg ±0.08%fs, [With input outside the range of 1,666% f.s. to 110% f.s. or a nominal input voltage of less than 100 V)  **PMS current**: ±0.29krdg ±0.08%fs, + clamp-on sensor accuracy**  **Voltage waveform peak/**  Display item	
RMS current : ±0.2% rdg.±0.1%fs. + clamp-on sensor accuracy  Voltage waveform peak / Current waveform peak positive peak value and negative peak value  Measurement method Measured every 10 cycles (50 Hz) or 12 cycles (60 Hz) maximum and minimum points sampled during approx. 200 ms aggregation  Sampling frequency Voltage waveform peak : ±1200.0 Vpeak, 0.1V  Current waveform comparison  Display item Event detection only  Measurement method A judgment area is automatically generated from the previous 200 ms aggregation waveform, and events are generated base on a comparison with the judgment waveform. Waveform judgments are performed once for each 200 ms aggregation.  Comparison window width 10 cycles (50 Hz), 12 cycles (60 Hz)  No. of window points 4096 points synchronized with harmonic calculations  Frequency cycle  Measurement method Calculated as the reciprocal of the accumulated whole-cycle time during one U1 (reference channel) cycle Measurement bandwidth 40.000 to 70.000Hz  Measurement bandwidth 40.000 to 70.000Hz  Measurement accuracy ±0.200 Hz or less (for input from 10% f.s. to 110% f.s.)  Frequency  Measurement method Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles Measurement trange, resolution 70.000Hz, 0.001Hz  Measurement accuracy ±0.020 Hz or less (for input from 10% f.s. to 110% f.s.)  TIME PLOT  Measurement accuracy ±0.020 Hz or less  10-sec frequency  Measurement method Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles Measurement arrange, resolution 70.000Hz  Measurement method Calculated as the reciprocal of the accumulated whole-cycle time during the specifie	
Voltage waveform peak/ Current waveform peak  Display item  Positive peak value and negative peak value  Measurement method  Measured every 10 cycles (50 Hz) or 12 cycles (60 Hz) maximum and minimum points sampled during approx. 200 ms aggregation  Sampling frequency  200kHz  Measurement range, resolution  Voltage waveform peak: ±1200.0 Vpeak, 0.1V Current waveform peak: The quadruple of RMS current measurement range (Based on clamp-on sensor in use; See Input specification:  Voltage waveform comparison  EVENT  Display item  Event detection only  Measurement method  A judgment area is automatically generated from the previous 200 ms aggregation waveform, and events are generated base on a comparison with the judgment waveform. Waveform judgments are performed once for each 200 ms aggregation.  Comparison window width  10 cycles (50 Hz), 12 cycles (60 Hz)  No. of window points  4096 points synchronized with harmonic calculations  Frequency cycle  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during one U1 (reference channel) cycle  Measurement trange, resolution  Measurement accuracy  ±0.200 Hz or less (for input from 10% f.s. to 110% f.s.)  Frequency  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles  Measurement trange, resolution  70.000Hz, 0.001Hz  Measurement trange, resolution  Measurement trange, resolution  Measurement trange, resolution  70.000Hz, 0.001Hz  Measurement trange, resolution  Measurement trange, resolution  Measurement trange, resolution  70.000Hz, 0.001Hz  Measurement trange, resolution  Measurement trange, resolution  Measurement trange, resolution  Measurement trange, resolution  70.000Hz, 0.001Hz  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during the specified 10s period for U1 (reference channel) cycles  TIME PLOT  TI	
Display item  Measurement method  Measured every 10 cycles (50 Hz) or 12 cycles (60 Hz) maximum and minimum points sampled during approx. 200 ms aggregation  Sampling frequency  200kHz  Voltage waveform peak: ±1200.0 Vpeak, 0.1V Current waveform peak: ±1200.0 Vpeak, 0.1V Current waveform comparison  EVENT  Display item  Event detection only  Measurement method  A judgment area is automatically generated from the previous 200 ms aggregation waveform, and events are generated base on a comparison with the judgment waveform. Waveform judgments are performed once for each 200 ms aggregation.  Comparison window width  10 cycles (50 Hz), 12 cycles (60 Hz)  No. of window points  4096 points synchronized with harmonic calculations  Frequency cycle  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during one U1 (reference channel) cycle  Measurement range, resolution  Measurement accuracy  ±0.200 Hz or less (for input from 10% f.s. to 110% f.s.)  Frequency  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles  Measurement accuracy  ±0.200 Hz or less  10-sec frequency  Measurement tandwidth  Measurement tandwidth  Measurement tandwidth  Measurement range, resolution  Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles  Measurement accuracy  ±0.020 Hz or less  10-sec frequency  Measurement tandwidth  Measurem	
Measurement method Measurement method Measurement method Measurement range, resolution  Sampling frequency 200kHz  Measurement range, resolution  Voltage waveform comparison  Event detection only  Measurement method A judgment area is automatically generated from the previous 200 ms aggregation waveform, and events are generated base on a comparison window width 10 cycles (50 Hz), 12 cycles (60 Hz)  No. of window points 4096 points synchronized with harmonic calculations  Frequency cycle  Measurement method Calculated as the reciprocal of the accumulated whole-cycle time during one U1 (reference channel) cycle Measurement accuracy ± 0.200 Hz or less (for input from 10% f.s. to 110% f.s.)  Frequency  Measurement method Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycle Measurement accuracy ± 0.200 Hz or less (for input from 10% f.s. to 110% f.s.)  Frequency  Measurement behod Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles (sessurement behod)  Measurement method Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles (sessurement accuracy ± 0.200 Hz or less (for input from 10% f.s. to 110% f.s.)  Frequency  Measurement behod/  Measurement behod/with 40,000 to 70,000Hz  Measurement behod/with 40,000 to 70,000Hz  Measurement accuracy ± 0.200 Hz or less  10-sec frequency  Measurement method Calculated as the reciprocal of the accumulated whole-cycle time during the specified 10s period for U1 (reference channel) as per IEC61000-4-30 Measurement range, resolution  Measurement method Calculated as the reciprocal of the accumulated whole-cycle time during the specified 10s period for U1 (reference channel) as per IEC61000-4-30 Measurement method 40,000 to 70,000Hz	
maximum and minimum points sampled during approx. 200 ms aggregation  200kHz  Measurement range, resolution  Voltage waveform peak: ±1200.0 Vpeak, 0.1V  Current waveform peak: The quadruple of RMS current measurement range (Based on clamp-on sensor in use; See Input specification:  Voltage waveform comparison  EVENT  Display item  Event detection only  Measurement method  A judgment area is automatically generated from the previous 200 ms aggregation waveform, and events are generated base on a comparison with the judgment waveform. Waveform judgments are performed once for each 200 ms aggregation.  Comparison window width  10 cycles (50 Hz), 12 cycles (60 Hz)  No. of window points  4096 points synchronized with harmonic calculations  Frequency cycle  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during one U1 (reference channel) cycle  Measurement range, resolution  Measurement accuracy  ±0.200 Hz or less (for input from 10% f.s. to 110% f.s.)  Frequency  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles  Measurement method  Measurement bandwidth  40.000 to 70.000Hz  Measurement bandwidth  40.000 to 70.000Hz  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during the specified 10s period for U1 (reference channel) as per IEC61000-4-30  Measurement method  Measurement method  Measurement method  Measurement method  Adouble to FMS  TIME PLOT  Time PLOT  Measu	
Sampling frequency  Measurement range, resolution  Voltage waveform peak : ±1200.0 Vpeak, 0.1V Current waveform peak : ±1200.0 Vpeak, 0.1V Current waveform peak : ±1200.0 Vpeak, 0.1V Current waveform peak : ±1200.0 Vpeak, 0.1V Voltage waveform comparison  Display item  Event detection only  Measurement method  A judgment area is automatically generated from the previous 200 ms aggregation waveform, and events are generated base on a comparison with the judgment waveform. Waveform judgments are performed once for each 200 ms aggregation.  Comparison window width  10 cycles (60 Hz), 12 cycles (60 Hz)  No. of window points  4096 points synchronized with harmonic calculations  Frequency cycle  Measurement method  Measurement method  Measurement range, resolution  Measurement range, resolution  Measurement accuracy  ±0.200 Hz or less (for input from 10% f.s. to 110% f.s.)  Frequency  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles  Measurement accuracy  ±0.020 Hz or less  10-sec frequency  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during the specified 10s period for U1 (reference channel) as per IEC61000-4-30  Measurement range, resolution  Measurement range, resolution  Measurement range, resolution  Measurement range, resolution  A 0.000 Hz, 0.001Hz  Measurement range, resolution  Measurement range, resolution  Measurement range, resolution  A 0.000 Hz, 0.001Hz  Measurement bandwidth  40.000 to 70.000Hz  40.000 Hz, 0.001Hz  Measurement bandwidth  40.000 to 70.000Hz	
Measurement range, resolution  Voltage waveform peak : ±1200.0 Vpeak, 0.1V Current waveform peak : ±1200.0 Vpeak, 0.1V The quadruple of RMS current measurement range (Based on clamp-on sensor in use; See Input specification)  Display item  Event detection only Measurement method A judgment area is automatically generated from the previous 200 ms aggregation waveform, and events are generated base on a comparison window width 10 cycles (50 Hz), 12 cycles (60 Hz) No. of window points  Frequency cycle  Measurement method Calculated as the reciprocal of the accumulated whole-cycle time during one U1 (reference channel) cycle Measurement bandwidth 40.000 to 70.000Hz Measurement accuracy 40.200 Hz or less (for input from 10% f.s. to 110% f.s.)  Frequency Measurement method Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles Measurement method Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles Measurement bandwidth 40.000 to 70.000Hz Measurement bandwidth 40.000 to 70.000Hz Measurement method Calculated as the reciprocal of the accumulated whole-cycle time during the specified 10s period for U1 (reference channel) as per IEC61000-4-30 Measurement method Calculated as the reciprocal of the accumulated whole-cycle time during the specified 10s period for U1 (reference channel) as per IEC61000-4-30 Measurement range, resolution Measurement bandwidth 40.000 to 70.000Hz 40.000 to 70.000Hz	
Current waveform peak: The quadruple of RMS current measurement range (Based on clamp-on sensor in use; See Input specifications)  Voltage waveform comparison  Event  Event detection only  Measurement method  A judgment area is automatically generated from the previous 200 ms aggregation waveform, and events are generated base on a comparison with the judgment waveform. Waveform judgments are performed once for each 200 ms aggregation.  Comparison window width  No. of window points  4096 points synchronized with harmonic calculations  Frequency cycle  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during one U1 (reference channel) cycle  Measurement bandwidth  40.000 to 70.000Hz  Measurement accuracy  ±0.200 Hz or less (for input from 10% f.s. to 110% f.s.)  Frequency  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles  Measurement bandwidth  40.000 to 70.000Hz  Measurement bandwidth  40.000 to 70.000Hz  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during the specified 10s period for U1 (reference channel) as per IEC61000-4-30  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during the specified 10s period for U1 (reference channel) as per IEC61000-4-30  Measurement range, resolution  70.000Hz, 0.001Hz  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during the specified 10s period for U1 (reference channel) as per IEC61000-4-30  Measurement range, resolution  70.000Hz, 0.001Hz	
Display item	
Display item Event detection only  Measurement method A judgment area is automatically generated from the previous 200 ms aggregation waveform, and events are generated base on a comparison with the judgment waveform. Waveform judgments are performed once for each 200 ms aggregation.  Comparison window width 10 cycles (50 Hz), 12 cycles (60 Hz)  No. of window points 4096 points synchronized with harmonic calculations  Frequency cycle  Measurement method Calculated as the reciprocal of the accumulated whole-cycle time during one U1 (reference channel) cycle Measurement range, resolution 70.000Hz, 0.001Hz  Measurement bandwidth 40.000 to 70.000Hz  Measurement accuracy ±0.200 Hz or less (for input from 10% f.s. to 110% f.s.)  Frequency  Measurement method Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles Measurement method 70.000Hz, 0.001Hz  Measurement bandwidth 40.000 to 70.000Hz  Measurement bandwidth 40.000 to 70.000Hz  Measurement accuracy ±0.020 Hz or less  10-sec frequency  Measurement method Calculated as the reciprocal of the accumulated whole-cycle time during the specified 10s period for U1 (reference channel) as per IEC61000-4-30 Measurement method Calculated as the reciprocal of the accumulated whole-cycle time during the specified 10s period for U1 (reference channel) as per IEC61000-4-30 Measurement method Measurement bandwidth 40.000 to 70.000Hz  Measurement bandwidth 40.000 to 70.000Hz	
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on a comparison with the judgment waveform. Waveform judgments are performed once for each 200 ms aggregation.  Comparison window width  10 cycles (50 Hz), 12 cycles (60 Hz)  4096 points synchronized with harmonic calculations  Frequency cycle  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during one U1 (reference channel) cycle  Measurement range, resolution  Measurement bandwidth  40.000 to 70.000Hz  Measurement accuracy  **Description**  TIME PLOT  EVENT  Measurement bandwidth  40.000 to 70.000Hz  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles  Measurement trange, resolution  70.000Hz, 0.001Hz  Measurement bandwidth  40.000 to 70.000Hz  Measurement bandwidth  40.000 to 70.000Hz  Measurement bandwidth  40.000 to 70.000Hz  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles  **Measurement trange, resolution**  70.000Hz, 0.001Hz  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during the specified 10s period for U1 (reference channel) as per IEC61000-4-30  Measurement range, resolution  70.000Hz, 0.001Hz  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during the specified 10s period for U1 (reference channel) as per IEC61000-4-30  Measurement bandwidth  40.000 to 70.000Hz	
No. of window points  4096 points synchronized with harmonic calculations  Frequency cycle  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during one U1 (reference channel) cycle  Measurement range, resolution  Measurement bandwidth  40.000 to 70.000Hz  Measurement accuracy  ±0.200 Hz or less (for input from 10% f.s. to 110% f.s.)  Frequency  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles  Measurement range, resolution  70.000Hz, 0.001Hz  Measurement bandwidth  40.000 to 70.000Hz  Measurement accuracy  ±0.020 Hz or less  10-sec frequency  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during the specified 10s period for U1 (reference channel) as per IEC61000-4-30  Measurement range, resolution  70.000Hz, 0.001Hz  Measurement range, resolution  Measurement bandwidth  40.000 to 70.000Hz  40.000 Hz, 0.001Hz  Measurement bandwidth  40.000 to 70.000Hz  40.000 Hz  40.000 to 70.000Hz	Event detection only
Frequency cycle  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during one U1 (reference channel) cycle  Measurement range, resolution  Measurement bandwidth  Measurement accuracy  Frequency  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles  Measurement mange, resolution  70.000Hz, 0.001Hz  Measurement accuracy  ±0.020 Hz or less  10-sec frequency  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during the specified 10s period for U1 (reference channel) as per IEC61000-4-30  Measurement range, resolution  70.000Hz, 0.001Hz  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during the specified 10s period for U1 (reference channel) as per IEC61000-4-30  Measurement range, resolution  70.000Hz, 0.001Hz  Measurement bandwidth  40.000 to 70.000Hz	Event detection only  A judgment area is automatically generated from the previous 200 ms aggregation waveform, and events are generated base
Measurement method Calculated as the reciprocal of the accumulated whole-cycle time during one U1 (reference channel) cycle  Measurement range, resolution 70.000Hz, 0.001Hz  Measurement bandwidth 40.000 to 70.000Hz  Measurement accuracy ±0.200 Hz or less (for input from 10% f.s. to 110% f.s.)  Frequency TIME PLOT EVENT  Measurement method Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles  Measurement range, resolution 70.000Hz, 0.001Hz  Measurement accuracy ±0.020 Hz or less  10-sec frequency TIME PLOT  Measurement method Calculated as the reciprocal of the accumulated whole-cycle time during the specified 10s period for U1 (reference channel) as per IEC61000-4-30  Measurement range, resolution 70.000Hz, 0.001Hz  Measurement bandwidth 40.000 to 70.000Hz  Measurement bandwidth 40.000 to 70.000Hz  Measurement bandwidth 40.000 to 70.000Hz	Event detection only  A judgment area is automatically generated from the previous 200 ms aggregation waveform, and events are generated base on a comparison with the judgment waveform. Waveform judgments are performed once for each 200 ms aggregation.
Measurement method Calculated as the reciprocal of the accumulated whole-cycle time during one U1 (reference channel) cycle  Measurement range, resolution 70.000Hz, 0.001Hz  Measurement bandwidth 40.000 to 70.000Hz  Measurement accuracy ±0.200 Hz or less (for input from 10% f.s. to 110% f.s.)  Frequency TIME PLOT EVENT  Measurement method Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles  Measurement range, resolution 70.000Hz, 0.001Hz  Measurement accuracy ±0.020 Hz or less  10-sec frequency TIME PLOT  Measurement method Calculated as the reciprocal of the accumulated whole-cycle time during the specified 10s period for U1 (reference channel) as per IEC61000-4-30  Measurement range, resolution 70.000Hz, 0.001Hz  Measurement bandwidth 40.000 to 70.000Hz  Measurement bandwidth 40.000 to 70.000Hz  Measurement bandwidth 40.000 to 70.000Hz	Event detection only  A judgment area is automatically generated from the previous 200 ms aggregation waveform, and events are generated base on a comparison with the judgment waveform. Waveform judgments are performed once for each 200 ms aggregation.  10 cycles (50 Hz), 12 cycles (60 Hz)
Measurement range, resolution Measurement bandwidth Measurement accuracy  Frequency  Measurement method Measurement bandwidth Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles Measurement bandwidth  Measurement accuracy  TIME PLOT  EVENT  Measurement range, resolution  70.000 Hz, 0.001 Hz  Measurement bandwidth  40.000 to 70.000 Hz  Measurement accuracy  ±0.020 Hz or less  TIME PLOT  Measurement accuracy  TIME PLOT  Measurement range, resolution  Calculated as the reciprocal of the accumulated whole-cycle time during the specified 10s period for U1 (reference channel) as per IEC61000-4-30 Measurement range, resolution  70.000 Hz, 0.001 Hz  Measurement bandwidth  40.000 to 70.000 Hz  40.000 to 70.000 Hz	Event detection only  A judgment area is automatically generated from the previous 200 ms aggregation waveform, and events are generated base on a comparison with the judgment waveform. Waveform judgments are performed once for each 200 ms aggregation.  10 cycles (50 Hz), 12 cycles (60 Hz)  4096 points synchronized with harmonic calculations
Measurement bandwidth  Measurement accuracy  #0.200 Hz or less (for input from 10% f.s. to 110% f.s.)  Frequency  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles  Measurement range, resolution  70.000 Hz, 0.001 Hz  Measurement bandwidth  40.000 to 70.000 Hz  40.000 to 70.000 Hz  #0.020 Hz or less  TIME PLOT  TIME PLOT  Measurement accuracy  #10-sec frequency  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during the specified 10s period for U1 (reference channel) as per IEC61000-4-30 Measurement bandwidth  Measurement bandwidth  40.000 to 70.000 Hz  Measurement range, resolution  70.000 Hz, 0.001 Hz  Measurement bandwidth  40.000 to 70.000 Hz	Event detection only  A judgment area is automatically generated from the previous 200 ms aggregation waveform, and events are generated base on a comparison with the judgment waveform. Waveform judgments are performed once for each 200 ms aggregation.  10 cycles (50 Hz), 12 cycles (60 Hz)  4096 points synchronized with harmonic calculations
£0.200 Hz or less (for input from 10% f.s. to 110% f.s.)   Frequency	Event detection only  A judgment area is automatically generated from the previous 200 ms aggregation waveform, and events are generated base on a comparison with the judgment waveform. Waveform judgments are performed once for each 200 ms aggregation.  10 cycles (50 Hz), 12 cycles (60 Hz)  4096 points synchronized with harmonic calculations  TIME PLOT  EVENT  Calculated as the reciprocal of the accumulated whole-cycle time during one U1 (reference channel) cycle
Frequency  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles  Measurement range, resolution  70.000Hz, 0.001Hz  Measurement bandwidth  40.000 to 70.000Hz  Measurement accuracy  ±0.020 Hz or less  10-sec frequency  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during the specified 10s period for U1 (reference channel) as per IEC61000-4-30  Measurement range, resolution  70.000Hz, 0.001Hz  Measurement bandwidth  40.000 to 70.000Hz	Event detection only  A judgment area is automatically generated from the previous 200 ms aggregation waveform, and events are generated base on a comparison with the judgment waveform. Waveform judgments are performed once for each 200 ms aggregation.  10 cycles (50 Hz), 12 cycles (60 Hz)  4096 points synchronized with harmonic calculations  TIME PLOT  EVENT  Calculated as the reciprocal of the accumulated whole-cycle time during one U1 (reference channel) cycle  70.000Hz, 0.001Hz
Measurement method Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles  Measurement range, resolution 70.000Hz, 0.001Hz Measurement bandwidth 40.000 to 70.000Hz Measurement accuracy ±0.020 Hz or less  TIME PLOT  Measurement method Calculated as the reciprocal of the accumulated whole-cycle time during the specified 10s period for U1 (reference channel) as per IEC61000-4-30  Measurement range, resolution Measurement bandwidth 40.000 to 70.000Hz 40.000 to 70.000Hz 40.000 to 70.000Hz	Event detection only  A judgment area is automatically generated from the previous 200 ms aggregation waveform, and events are generated base on a comparison with the judgment waveform. Waveform judgments are performed once for each 200 ms aggregation.  10 cycles (50 Hz), 12 cycles (60 Hz)  4096 points synchronized with harmonic calculations  TIME PLOT  EVENT  Calculated as the reciprocal of the accumulated whole-cycle time during one U1 (reference channel) cycle  70.000Hz, 0.001Hz  40.000 to 70.000Hz
Measurement range, resolution 70.000 Hz, 0.001 Hz Measurement bandwidth 40.000 to 70.000 Hz Measurement accuracy ±0.020 Hz or less  10-sec frequency Measurement method Calculated as the reciprocal of the accumulated whole-cycle time during the specified 10s period for U1 (reference channel) as per IEC61000-4-30 Measurement range, resolution Measurement bandwidth 40.000 to 70.000 Hz 40.000 to 70.000 Hz	Event detection only  A judgment area is automatically generated from the previous 200 ms aggregation waveform, and events are generated base on a comparison with the judgment waveform. Waveform judgments are performed once for each 200 ms aggregation.  10 cycles (50 Hz), 12 cycles (60 Hz)  4096 points synchronized with harmonic calculations  TIME PLOT  EVENT  Calculated as the reciprocal of the accumulated whole-cycle time during one U1 (reference channel) cycle  70.000Hz, 0.001Hz  40.000 to 70.000Hz  ±0.200 Hz or less (for input from 10% f.s. to 110% f.s.)
Measurement bandwidth  40.000 to 70.000Hz  Measurement accuracy  ±0.020 Hz or less  10-sec frequency  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during the specified 10s period for U1 (reference channel) as per IEC61000-4-30  Measurement range, resolution  Measurement bandwidth  40.000 to 70.000Hz  40.000 to 70.000Hz	Event detection only  A judgment area is automatically generated from the previous 200 ms aggregation waveform, and events are generated base on a comparison with the judgment waveform. Waveform judgments are performed once for each 200 ms aggregation.  10 cycles (50 Hz), 12 cycles (60 Hz)  4096 points synchronized with harmonic calculations  TIME PLOT  EVENT  Calculated as the reciprocal of the accumulated whole-cycle time during one U1 (reference channel) cycle  70.000Hz, 0.001Hz  40.000 to 70.000Hz  ±0.200 Hz or less (for input from 10% f.s. to 110% f.s.)
Measurement accuracy ±0.020 Hz or less  10-sec frequency  Measurement method  Calculated as the reciprocal of the accumulated whole-cycle time during the specified 10s period for U1 (reference channel) as per IEC61000-4-30  Measurement range, resolution  Measurement bandwidth  40.000 to 70.000Hz	Event detection only  A judgment area is automatically generated from the previous 200 ms aggregation waveform, and events are generated base on a comparison with the judgment waveform. Waveform judgments are performed once for each 200 ms aggregation.  10 cycles (50 Hz), 12 cycles (60 Hz)  4096 points synchronized with harmonic calculations  TIME PLOT EVENT  Calculated as the reciprocal of the accumulated whole-cycle time during one U1 (reference channel) cycle  70.000Hz, 0.001Hz  40.000 to 70.000Hz  ±0.200 Hz or less (for input from 10% f.s. to 110% f.s.)  TIME PLOT EVENT  Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles
10-sec frequency Measurement method Measurement range, resolution Measurement bandwidth  Calculated as the reciprocal of the accumulated whole-cycle time during the specified 10s period for U1 (reference channel) as per IEC61000-4-30  Measurement bandwidth  40.000 to 70.000Hz	Event detection only  A judgment area is automatically generated from the previous 200 ms aggregation waveform, and events are generated base on a comparison with the judgment waveform. Waveform judgments are performed once for each 200 ms aggregation.  10 cycles (50 Hz), 12 cycles (60 Hz)  4096 points synchronized with harmonic calculations  TIME PLOT EVENT  Calculated as the reciprocal of the accumulated whole-cycle time during one U1 (reference channel) cycle  70.000Hz, 0.001Hz  40.000 to 70.000Hz  ±0.200 Hz or less (for input from 10% f.s. to 110% f.s.)  TIME PLOT EVENT  Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles  70.000Hz, 0.001Hz
Measurement method Calculated as the reciprocal of the accumulated whole-cycle time during the specified 10s period for U1 (reference channel) as per IEC61000-4-30 Measurement range, resolution 70.000Hz, 0.001Hz  Measurement bandwidth 40.000 to 70.000Hz	Event detection only  A judgment area is automatically generated from the previous 200 ms aggregation waveform, and events are generated base on a comparison with the judgment waveform. Waveform judgments are performed once for each 200 ms aggregation.  10 cycles (50 Hz), 12 cycles (60 Hz)  4096 points synchronized with harmonic calculations  TIME PLOT EVENT  Calculated as the reciprocal of the accumulated whole-cycle time during one U1 (reference channel) cycle  70.000Hz, 0.001Hz  40.000 to 70.000Hz  ±0.200 Hz or less (for input from 10% f.s. to 110% f.s.)  TIME PLOT EVENT  Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles  70.000Hz, 0.001Hz  40.000 to 70.000Hz
Measurement range, resolution 70.000Hz, 0.001Hz  Measurement bandwidth 40.000 to 70.000Hz	Event detection only  A judgment area is automatically generated from the previous 200 ms aggregation waveform, and events are generated base on a comparison with the judgment waveform. Waveform judgments are performed once for each 200 ms aggregation.  10 cycles (50 Hz), 12 cycles (60 Hz)  4096 points synchronized with harmonic calculations  TIME PLOT EVENT  Calculated as the reciprocal of the accumulated whole-cycle time during one U1 (reference channel) cycle  70.000Hz, 0.001Hz  40.000 to 70.000Hz  ±0.200 Hz or less (for input from 10% f.s. to 110% f.s.)  TIME PLOT EVENT  Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles  70.000Hz, 0.001Hz  40.000 to 70.000Hz  ±0.020 Hz or less
Measurement bandwidth 40.000 to 70.000Hz	Event detection only  A judgment area is automatically generated from the previous 200 ms aggregation waveform, and events are generated base on a comparison with the judgment waveform. Waveform judgments are performed once for each 200 ms aggregation.  10 cycles (50 Hz), 12 cycles (60 Hz)  4096 points synchronized with harmonic calculations  TIME PLOT EVENT  Calculated as the reciprocal of the accumulated whole-cycle time during one U1 (reference channel) cycle  70.000Hz, 0.001Hz  40.000 to 70.000Hz  ±0.200 Hz or less (for input from 10% f.s. to 110% f.s.)  TIME PLOT EVENT  Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles  70.000Hz, 0.001Hz  40.000 to 70.000Hz  ±0.020 Hz or less
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10.010 Fiz 01 1635	Event detection only  A judgment area is automatically generated from the previous 200 ms aggregation waveform, and events are generated base on a comparison with the judgment waveform. Waveform judgments are performed once for each 200 ms aggregation.  10 cycles (50 Hz), 12 cycles (60 Hz)  4096 points synchronized with harmonic calculations  TIME PLOT EVENT  Calculated as the reciprocal of the accumulated whole-cycle time during one U1 (reference channel) cycle  70.000Hz, 0.001Hz  40.000 to 70.000Hz  ±0.200 Hz or less (for input from 10% f.s. to 110% f.s.)  TIME PLOT EVENT  Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles  70.000Hz, 0.001Hz  40.000 to 70.000Hz  ±0.020 Hz or less  TIME PLOT  EVENT  Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles  70.000Hz, 0.001Hz  40.000 to 70.000Hz  ±0.020 Hz or less
	Event detection only  A judgment area is automatically generated from the previous 200 ms aggregation waveform, and events are generated base on a comparison with the judgment waveform. Waveform judgments are performed once for each 200 ms aggregation.  10 cycles (50 Hz), 12 cycles (60 Hz)  4096 points synchronized with harmonic calculations  TIME PLOT  EVENT  Calculated as the reciprocal of the accumulated whole-cycle time during one U1 (reference channel) cycle  70.000Hz, 0.001Hz  40.000 to 70.000Hz  ±0.200 Hz or less (for input from 10% f.s. to 110% f.s.)  TIME PLOT  EVENT  Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles  70.000Hz, 0.001Hz  40.000 to 70.000Hz  ±0.020 Hz or less  TIME PLOT  Calculated as the reciprocal of the accumulated whole-cycle time during the specified 10s period for U1 (reference channel) as per IEC61000-4-30  70.000Hz, 0.001Hz  40.000 to 70.000Hz
	Event detection only  A judgment area is automatically generated from the previous 200 ms aggregation waveform, and events are generated base on a comparison with the judgment waveform. Waveform judgments are performed once for each 200 ms aggregation.  10 cycles (50 Hz), 12 cycles (60 Hz)  4096 points synchronized with harmonic calculations  TIME PLOT  EVENT  Calculated as the reciprocal of the accumulated whole-cycle time during one U1 (reference channel) cycle  70.000Hz, 0.001Hz  40.000 to 70.000Hz  ±0.200 Hz or less (for input from 10% f.s. to 110% f.s.)  TIME PLOT  EVENT  Calculated as the reciprocal of the accumulated whole-cycle time during approx. 200ms period of 10 or 12 U1 (reference channel) cycles  70.000Hz, 0.001Hz  40.000 to 70.000Hz  ±0.020 Hz or less  TIME PLOT  Calculated as the reciprocal of the accumulated whole-cycle time during the specified 10s period for U1 (reference channel) as per IEC61000-4-30  70.000Hz, 0.001Hz  40.000 to 70.000Hz
Comparison window width No. of window points  Frequency cycle  Measurement method  Measurement range, resolution  Measurement bandwidth  Measurement accuracy  Frequency  Measurement method  Measurement bandwidth  Measurement bandwidth  Measurement accuracy  10-sec frequency  Measurement method  Measurement accuracy  Measurement accuracy  10-sec frequency  Measurement method  Measurement method  Measurement range, resolution  Measurement bandwidth	

Voltage DC value (ch4 only)		TIME PLOT	EVENT
Measurement method	Average value during approx. 20ms aggregation synchronized with the reference channel (C	CH4 only)	
Sampling frequency	200kHz		
Measurement range, resolution  Measurement accuracy	600.00V, 0.01V ±0.3%rdg, ±0.08%f.s.		
		TIME DI OT	EVENT
Measurement method	when using compatible sensor)  Average value during approx. 200ms aggregation synchronized to reference channel (CH4)	only)	EVENT
Sampling frequency	200kHz	Orny)	
Measurement range, resolution	Based on clamp-on sensor in use (with release of new clamp-on sensor)		
Measurement accuracy	±0.5% rdg.±0.5%f.s. + clamp-on sensor accuracy		
Active power/ Apparent po	wer/ Reactive power	TIME PLOT	EVENT
Display items	Active power: Active power for each channel and sum value for multiple channels. Sink (consumption) and Source (regeneration)  Apparent power: Apparent power of each channel and its sum for multiple channels No polarity  Reactive power: Reactive power of each channel and its sum for multiple channels Lag phase (LAG: current lags voltage) and Lead phase (LEAD: current leace	ds voltage)	
Measurement method	Active power: Measured every 10 cycles (50 Hz) or 12 cycles (60 Hz) Apparent power: Calculated from RMS voltage U and RMS current I Reactive power: Calculated using apparent power S and active power P		
Sampling frequency	200kHz		
Measurement range, resolution Measurement accuracy	Depends on the voltage × current range combination; see Input specifications  Active power: ±0.2% rdg.±0.1%f.s. + clamp-on sensor accuracy  Apparent power: ±1 dgt. for calculations derived from the various measurement values  Reactive power: ±1 dgt. for calculations derived from the various measurement values		
Active energy /Reactive en	ergy	TIME PLOT	
Display items	Active energy: WP+ (consumption), WP- (regeneration); Sum of multiple channels Reactive energy: WQLAG (lag), WQLEAD (lead); Sum for multiple channels Elapsed time		
Measurement method	Measured every 10 cycles (50 Hz) or 12 cycles (60 Hz) Integrated separately by consumption and regeneration from active power Integrated separately by lag and lead from reactive power Integration starts at the same time as recording Recorded at the specified TIMEPLOT interval		
Sampling frequency	200kHz		
Measurement range, resolution  Measurement accuracy	Depends on the voltage × current range combination; see Input specifications  Active energy: Active power measurement accuracy ±10 dgt.		
Weasurement accuracy	Reactive energy: Reactive power measurement accuracy ±10 dgt.		
Power factor / Displacemen	t power factor	TIME PLOT	EVENT
Display items	Displacement power factor of each channel and its sum value for multiple channels		
Measurement method	Power factor : Calculated from RMS voltage U, RMS current I, and active po Displacement power factor : Calculated from the phase difference between the fundamental voltage Lag phase (LAG: current lags voltage) and Lead phase (LEAD: current leads voltage		ental current wave
Sampling frequency	200kHz		
Measurement range, resolution	-1.0000 (lead) to 0.0000 to 1.0000 (lag)		
<u> </u>	Current unbalance factor (negative-phase, zero-phase)	TIME PLOT	
Display items	Voltage unbalance factor : Negative-phase unbalance factor, zero-phase unbalance factor : Negative-phase unbalance factor, zero-phase unbalance factor gative-phase unbalance factor, zero-phase unbalance factor.		
Measurement method	Calculated using various components of the three-phase fundamental wave (line-to-line volt		se 3-wire
	(3P3W2M, 3P3W3M) and three-phase 4-wire connections		
Sampling frequency	200kHz  Voltage unbalance factor : Component is V and unbalance factor is 0.00% to 100.00%		
Measurement range	Voltage unbalance factor : Component is V and unbalance factor is 0.00% to 100.00% Current unbalance factor : Component is A and unbalance factor is 0.00% to 100.00%		
Measurement accuracy	Voltage unbalance factor : ±0.15% Current unbalance factor : —		
High-order harmonic voltac	ge component/ High-order harmonic current component	TIME PLOT	EVENT
Display items	For single incidents and continuous transient incidents High-order harmonic voltage component value High-order harmonic current component value For continuous incidents High-order harmonic voltage component maximum value		
	High-order harmonic current component maximum value High-order harmonic voltage component period High-order harmonic current component period		
Measurement method	The waveform obtained by eliminating the fundamental component is calculated using the trule. Hz) or 12 cycles (60 Hz) of the fundamental wave	ue RMS method du	uring 10 cycles (50
Sampling frequency	200kHz		
Measurement range, resolution	High-order harmonic voltage component: 600.00V, 0.01V High-order harmonic current component: Based on clamp-on sensor in use; See Input sp	pecifications	
Measurement bandwidth	2kHz (-3dB) to 80kHz (-3dB)		
Measurement accuracy	High-order harmonic voltage component: ±10%rdg. ±0.1%f.s. High-order harmonic current component: ±10% rdg.±0.2%f.s. + clamp-on sensor accura	су	
Harmonic voltage/ Harmon Display items	ic current (including fundamental component)  Select either RMS or content percentage; From 0 to 50th order	TIME PLOT	EVENT
Measurement method	Uses IEC61000-4-7:2002.		
Comparison window width	10 cycles (50 Hz), 12 cycles (60 Hz)		
No. of window points	4096 points synchronized with harmonic calculations		
Measurement range, resolution	Harmonic voltage : 600.00V, 0.01V : Based on clamp-on sensor in use; see Input specifications		
Measurement	See measurement accuracy with a fundamental wave of 50/60 Hz		
accuracy	When using an AC-only clamp sensor, 0th order is not specified for current and power		

	tal harmonic current distortio				IME PLOT	EVENT
Display items	THD-F (total harmonic distortion fa		,	undamental ···-·		
Measurement method	THD-R (total harmonic distortion fa		ionic including the fu	iridamentai wave)		
Comparison window width	Based on IEC61000-4-7:2002; Max. order: 50th					
lo. of window points	10 cycles (50 Hz), 12 cycles (60 Hz) 4096 points synchronized with harmonic calculations					
Measurement range, resolution	0.00 to 100.00%(Voltage), 0.00 to					
Measurement accuracy		000.0070(00110111)				
larmonic power (including	fundamental component)				IME PLOT	EVENT
Display item	Select either RMS or content perce	entage: From 0 to 50t	h order		IME PLOT	EVENT
Measurement method	Uses IEC61000-4-7:2002.	entage, i form o to sot	ii oidei			
Comparison window width	10 cycles (50 Hz), 12 cycles (60 Hz	·)				
No. of window points	4096 points synchronized with hard					
Measurement range, resolution	Depends on the voltage × current r		ee Input specification	ns		
Measurement accuracy	See measurement accuracy with a fundar				is not specified for	or current and pow
,	Measurement accuracy with a		·			
	Harmonic input	Measurement accur				
	Voltage		ninal voltage of at least	100 V		_
	(At least 1% of nominal voltage)	Order 0: Order 1+:	±0.3%rdg.±0.08%f.s. ±5.00%rdq			
	Voltage		inal voltage of at least	100 V		_
	(<1% of nominal voltage)	Order 0: Order 1+:	±0.3%rdg.±0.08%f.s. ±0.05% of nominal vol			
	Current	Order 0: Order 1 to 20th:	±0.5%rdg.±0.5%f.s. ±0.5%rdg.±0.2%f.s.	+clamp-on sensor a +clamp-on sensor a	ccuracy	_
	Power	Order 21 to 50th:	±1.0%rdg.±0.3%f.s.	+clamp-on sensor a	-	_
	Power	Order 0: Order 1 to 20th:	±0.5%rdg.±0.5%f.s. ±0.5%rdg.±0.2%f.s.	+clamp-on sensor a +clamp-on sensor a		
		Order 21 to 30th:	±1.0%rdg.±0.3%f.s.	+clamp-on sensor a	ccuracy	
		Order 31 to 40th:	±2.0%rdg.±0.3%f.s.	+clamp-on sensor a		
amaania saltaaa ahaa	ale/Homesis survey by	Order 41 to 50th:	±3.0%rdg.±0.3%f.s.	+clamp-on sensor a		_
	ngle/ Harmonic current phase	<u> </u>	undamental com	ponent)	IME PLOT	
isplay item leasurement method	Harmonic phase angle component Uses IEC61000-4-7:2002.	s for writing orders				
		۸				
Comparison window width	10 cycles (50 Hz), 12 cycles (60 Hz	•				
lo. of window points	4096 points synchronized with har	monic calculations				
Measurement range, resolution Measurement accuracy	-180.00° to 0.00° to 180.00°					
					THE DLOT	EVENT
l <b>armonic voltage-current p</b> Display item	Indicates the difference between the	ne harmonic voltage p	hase angle and the	narmonic current p		EVENT
	Harmonic voltage-current phase di	ifference for each cha	innel and sum (total)	value for multiple c	nannels	
Measurement method	Uses IEC61000-4-7:2002.	`				
Comparison window width	10 cycles (50 Hz), 12 cycles (60 Hz					
lo. of window points	4096 points synchronized with harr	monic calculations				
Measurement range, resolution	-180.00° to 0.00° to 180.00°					
Measurement accuracy	1st to 3rd orders : ± 2° +clamp-o 4th to 50th orders : ±(0.05° × k+2° Specified with a harmonic voltage of	) +clamp-on sensor a			ar	
nter-harmonic voltage and	inter-harmonic current				IME PLOT	
Display item	Select either RMS or content perce	entage; 0.5 to 49.5th	orders			
Measurement method	Uses IEC61000-4-7:2002.					
Comparison window width	10 cycles (50 Hz), 12 cycles (60 Hz	,				
lo. of window points	4096 points synchronized with har					
Measurement range, resolution	Inter-harmonic voltage Inter-harmonic current		0.00V, 0.01V	onoori Coo Innut o	nacifications	
Measurement accuracy	Inter-harmonic voltage (Specified with a nomi		to using clamp-on			da
neasurement accuracy	Inter-naminoriic voitage specilieu will a noill		6 of harmonic input r			ag. f nominal voltad
	Inter-harmonic current		specified			
Factor (multiplication fac	tor)				IME PLOT	EVENT
<u> </u>		S current of the 2nd t	5011 1			
Measurement method	Calculated using the harmonic RM	o current or the zha t	o 50th orders			
	10 cycles (50 Hz), 12 cycles (60 Hz		o 50th orders			
Comparison window width	·	<u>.</u> )	o 50th orders			
Comparison window width No. of window points	10 cycles (50 Hz), 12 cycles (60 Hz	<u>.</u> )	o 50th orders			
Comparison window width  No. of window points  Measurement range, resolution	10 cycles (50 Hz), 12 cycles (60 Hz 4096 points synchronized with hard	<u>.</u> )	o 50th orders			
Measurement method Comparison window width No. of window points Measurement range, resolution Measurement accuracy Instantaneous flicker value	10 cycles (50 Hz), 12 cycles (60 Hz 4096 points synchronized with hard 0.00 to 500.00	<u>.</u> )	o 50th orders	ſ	IME PLOT	
Comparison window width  No. of window points  Measurement range, resolution  Measurement accuracy	10 cycles (50 Hz), 12 cycles (60 Hz 4096 points synchronized with hard 0.00 to 500.00	<u>.</u> )	o buth orders	ſ	IME PLOT	
Comparison window width No. of window points Measurement range, resolution Measurement accuracy Instantaneous flicker value	10 cycles (50 Hz), 12 cycles (60 Hz 4096 points synchronized with hard 0.00 to 500.00	t) monic calculations				120 Vlamp 60/50 H
Comparison window width No. of window points Measurement range, resolution Measurement accuracy Measurement method	10 cycles (50 Hz), 12 cycles (60 Hz 4096 points synchronized with hard 0.00 to 500.00 — As per IEC61000-4-15	t) monic calculations				120 Vlamp 60/50 H
Comparison window width Io. of window points Measurement range, resolution leasurement accuracy Instantaneous flicker value Measurement method Measurement range, resolution	10 cycles (50 Hz), 12 cycles (60 Hz) 4096 points synchronized with hard 0.00 to 500.00  As per IEC61000-4-15 User-selectable from 230 Vlamp/120 Vlamp (	t) monic calculations		/4 types of Ed2 filter (23)		120 Vlamp 60/50 H
comparison window width lo. of window points fleasurement range, resolution leasurement accuracy leasurement method fleasurement range, resolution V10 Flicker	10 cycles (50 Hz), 12 cycles (60 Hz) 4096 points synchronized with hard 0.00 to 500.00  As per IEC61000-4-15 User-selectable from 230 Vlamp/120 Vlamp (	e) monic calculations monic calculations when Pst and Plt are select	ed for flicker measurement	1/4 types of Ed2 filter (23	) Vlamp 50/60 Hz,	
Comparison window width Io. of window points Measurement range, resolution leasurement accuracy Instantaneous flicker value Measurement method Measurement range, resolution V10 Flicker	10 cycles (50 Hz), 12 cycles (60 Hz) 4096 points synchronized with hard 0.00 to 500.00  As per IEC61000-4-15 User-selectable from 230 Vlamp/120 Vlamp (99.999, 0.001	e) monic calculations when Pst and Plt are selectervals, average value for	ed for flicker measurement or one hour, maximu	1/4 types of Ed2 filter (23	) Vlamp 50/60 Hz,	
Comparison window width No. of window points Measurement range, resolution Measurement accuracy Instantaneous flicker value Measurement method Measurement range, resolution V10 Flicker Display items	10 cycles (50 Hz), 12 cycles (60 Hz) 4096 points synchronized with hard 0.00 to 500.00  As per IEC61000-4-15 User-selectable from 230 Vlamp/120 Vlamp (99.999, 0.001  ΔV10 measured at one minute inter	monic calculations  when Pst and Plt are selectervals, average value for tinterval) maximum v	ed for flicker measurement or one hour, maximulalue	/4 types of Ed2 filter (23)	O Vlamp 50/60 Hz,  TIME PLOT  Ir, fourth larges	
Comparison window width No. of window points Measurement range, resolution Measurement accuracy Instantaneous flicker value	10 cycles (50 Hz), 12 cycles (60 Hz) 4096 points synchronized with hard 0.00 to 500.00  As per IEC61000-4-15 User-selectable from 230 Vlamp/120 Vlamp (99.999, 0.001  ΔV10 measured at one minute interhour, total (within the measurement)	monic calculations  when Pst and Plt are selectervals, average value for tinterval) maximum v	ed for flicker measurement or one hour, maximulalue	/4 types of Ed2 filter (23)	O Vlamp 50/60 Hz,  TIME PLOT  Ir, fourth larges	
Comparison window width No. of window points Measurement range, resolution Measurement accuracy Instantaneous flicker value Measurement method Measurement range, resolution V10 Flicker Display items Measurement method	10 cycles (50 Hz), 12 cycles (60 Hz) 4096 points synchronized with hard 0.00 to 500.00  As per IEC61000-4-15 User-selectable from 230 Vlamp/120 Vlamp (99.999, 0.001  ΔV10 measured at one minute interhour, total (within the measurement Calculated values are subject to 10 0.000 to 99.999V ±2% rdg.±0.01 V (with a fundament)	when Pst and Plt are selectivals, average value for tinterval) maximum viol V conversion follow	ed for flicker measurement or one hour, maximu alue ring gap-less measu	1/4 types of Ed2 filter (23) m value for one hourement once each r	O Vlamp 50/60 Hz, TIME PLOT Ir, fourth larges minute	t value for one
Comparison window width No. of window points Measurement range, resolution Measurement accuracy Instantaneous flicker value Measurement method Measurement range, resolution V10 Flicker Display items Measurement method Measurement method Measurement range, resolution Measurement range, resolution Measurement accuracy	10 cycles (50 Hz), 12 cycles (60 Hz) 4096 points synchronized with hard 0.00 to 500.00  As per IEC61000-4-15 User-selectable from 230 Vlamp/120 Vlamp (99.999, 0.001   ΔV10 measured at one minute interhour, total (within the measurement Calculated values are subject to 100.000 to 99.999V ±2% rdg.±0.01 V (with a fundament of 10 Hz)	monic calculations  when Pst and Plt are selecter  rvals, average value for tinterval) maximum value of 100 Vrms	ed for flicker measurement or one hour, maximulalue ving gap-less measu [50/60 Hz], a fluctua	n value for one hourement once each ration voltage of 1 Vi	O Vlamp 50/60 Hz, TIME PLOT  Ir, fourth larges minute  rms, and a fluc	it value for one
Comparison window width Io. of window points Measurement range, resolution leasurement accuracy Instantaneous flicker value Measurement method Measurement range, resolution V10 Flicker Display items Measurement method Measurement range, resolution Measurement range, resolution Measurement range, resolution Measurement accuracy	10 cycles (50 Hz), 12 cycles (60 Hz) 4096 points synchronized with hard 0.00 to 500.00  As per IEC61000-4-15 User-selectable from 230 Vlamp/120 Vlamp (99.999, 0.001  ΔV10 measured at one minute interhour, total (within the measurement Calculated values are subject to 10 0.000 to 99.999V ±2% rdg.±0.01 V (with a fundament)	monic calculations  when Pst and Plt are selecter  rvals, average value for tinterval) maximum value of 100 Vrms	ed for flicker measurement or one hour, maximulalue ving gap-less measu [50/60 Hz], a fluctua	n value for one hourement once each ration voltage of 1 Vi	O Vlamp 50/60 Hz, TIME PLOT  Ir, fourth larges minute  rms, and a fluc	it value for one
comparison window width lo. of window points Measurement range, resolution leasurement accuracy Instantaneous flicker value Measurement method Measurement range, resolution V10 Flicker Display items Measurement method Measurement range, resolution Measurement accuracy Measurement accuracy	10 cycles (50 Hz), 12 cycles (60 Hz) 4096 points synchronized with hard 0.00 to 500.00  As per IEC61000-4-15 User-selectable from 230 Vlamp/120 Vlamp (99.999, 0.001   ΔV10 measured at one minute interhour, total (within the measurement Calculated values are subject to 100.000 to 99.999V ±2% rdg.±0.01 V (with a fundament of 10 Hz)	monic calculations  when Pst and Plt are selecter  rvals, average value for tinterval) maximum value of 100 Vrms	ed for flicker measurement or one hour, maximulalue ving gap-less measu [50/60 Hz], a fluctua	/4 types of Ed2 filter (23)  n value for one hourement once each ration voltage of 1 Viccompared to the the	O Vlamp 50/60 Hz, TIME PLOT  Ir, fourth larges minute  rms, and a fluc	it value for one
Comparison window width Io. of window points Measurement range, resolution Measurement accuracy Instantaneous flicker value Measurement method Measurement range, resolution V10 Flicker Display items Measurement method Measurement range, resolution Measurement accuracy Threshold EC Flicker	10 cycles (50 Hz), 12 cycles (60 Hz) 4096 points synchronized with hard 0.00 to 500.00  As per IEC61000-4-15 User-selectable from 230 Vlamp/120 Vlamp (99.999, 0.001   ΔV10 measured at one minute interhour, total (within the measurement Calculated values are subject to 100.000 to 99.999V ±2% rdg.±0.01 V (with a fundament of 10 Hz)	monic calculations  when Pst and Plt are selecter  rvals, average value for tinterval) maximum valous vonversion followed that wave of 100 Vrms  rated when the reading	ed for flicker measurement or one hour, maximulalue ving gap-less measu [50/60 Hz], a fluctua	/4 types of Ed2 filter (23)  n value for one hourement once each ration voltage of 1 Viccompared to the the	O Vlamp 50/60 Hz,  TIME PLOT  Ir, fourth larges  minute  rms, and a fluctoreshold and for	it value for one
Comparison window width No. of window points Measurement range, resolution Measurement accuracy Measurement method Measurement range, resolution V10 Flicker Display items Measurement method Measurement method	10 cycles (50 Hz), 12 cycles (60 Hz) 4096 points synchronized with hard 0.00 to 500.00  As per IEC61000-4-15 User-selectable from 230 Vlamp/120 Vlamp (99.999, 0.001  ΔV10 measured at one minute interhour, total (within the measurement Calculated values are subject to 100.000 to 99.999V ±2% rdg.±0.01 V (with a fundament of 10 Hz) 0.00 to 9.99V alarm output is gene	monic calculations  when Pst and Plt are selecter  rvals, average value for tinterval) maximum valou V conversion followed that wave of 100 Vrms or traced when the reading val flicker Plt	ed for flicker measurement or one hour, maximulalue ving gap-less measu [50/60 Hz], a fluctua	/4 types of Ed2 filter (23)  n value for one hourement once each ration voltage of 1 Viccompared to the the	O Vlamp 50/60 Hz,  TIME PLOT  Ir, fourth larges  minute  rms, and a fluctoreshold and for	it value for one
Comparison window width Io. of window points Measurement range, resolution leasurement accuracy Instantaneous flicker value Measurement method Measurement range, resolution V10 Flicker Display items Measurement method Measurement range, resolution Measurement accuracy Ihreshold EC Flicker Display items	10 cycles (50 Hz), 12 cycles (60 Hz) 4096 points synchronized with hard 0.00 to 500.00  As per IEC61000-4-15 User-selectable from 230 Vlamp/120 Vlamp (99.999, 0.001  AV10 measured at one minute interhour, total (within the measurement Calculated values are subject to 100.000 to 99.999V ±2% rdg.±0.01 V (with a fundament of 10 Hz) 0.00 to 9.99V alarm output is gene	when Pst and Plt are selected when Pst and Plt are selected to the pst and pst	ed for flicker measurement or one hour, maximu alue ring gap-less measu [50/60 Hz], a fluctua ng for each minute is	n value for one hourement once each ration voltage of 1 Viccompared to the the	O Vlamp 50/60 Hz,  TIME PLOT  Ir, fourth larges  minute  Irms, and a fluctureshold and for  TIME PLOT	t value for one
Comparison window width No. of window points Measurement range, resolution Measurement accuracy Measurement method Measurement range, resolution V10 Flicker Display items Measurement method Measurement method Measurement accuracy Measurement range, resolution Measurement range, resolution Measurement range, resolution Measurement range, resolution Measurement accuracy Threshold EC Flicker Display items	10 cycles (50 Hz), 12 cycles (60 Hz) 4096 points synchronized with hard 0.00 to 500.00  As per IEC61000-4-15 User-selectable from 230 Vlamp/120 Vlamp (99.999, 0.001  ΔV10 measured at one minute interhour, total (within the measurement Calculated values are subject to 100.000 to 99.999V ±2% rdg.±0.01 V (with a fundament of 10 Hz) 0.00 to 9.99V alarm output is gene  Short interval flicker Pst, long interval Based on IEC61000-4-15:1997 +A*	when Pst and Plt are selected when Pst and Plt are selected to the pst and pst	ed for flicker measurement or one hour, maximulalue lying gap-less measu [50/60 Hz], a fluctual ng for each minute is ement and Plt after 2	n value for one hourement once each ration voltage of 1 Viccompared to the the	O Vlamp 50/60 Hz,  TIME PLOT  Ir, fourth larges  minute  Irms, and a fluctureshold and for  TIME PLOT	t value for one
Comparison window width No. of window points Measurement range, resolution Measurement accuracy Measurement method Measurement range, resolution Measurement range, resolution N10 Flicker Display items Measurement method Measurement range, resolution Measurement accuracy Threshold EC Flicker Display items Measurement accuracy Measurement method Measurement accuracy	10 cycles (50 Hz), 12 cycles (60 Hz) 4096 points synchronized with hard 0.00 to 500.00  As per IEC61000-4-15 User-selectable from 230 Vlamp/120 Vlamp (99.999, 0.001  ΔV10 measured at one minute interhour, total (within the measurement Calculated values are subject to 100.000 to 99.999V ±2% rdg.±0.01 V (with a fundament of 10 Hz) 0.00 to 9.99V alarm output is gene  Short interval flicker Pst, long interval Based on IEC61000-4-15:1997 +A' Pst is calculated after 10 minutes of	when Pst and Plt are select rvals, average value for t interval) maximum v 00 V conversion follow that wave of 100 Vrms rated when the readin val flicker Plt 1:2003 Ed1/Ed2. of continuous measure ,024 segments with a	ed for flicker measurement or one hour, maximulalue ling gap-less measu [50/60 Hz], a fluctual ng for each minute is ement and Plt after 2 Logarithm	m value for one hour ement once each ration voltage of 1 Viccompared to the the	O Vlamp 50/60 Hz,  TIME PLOT  Ir, fourth larges  minute  Irms, and a fluctureshold and for  TIME PLOT  IS measurement	t value for one tuation frequence bund to be greated

### Clamp-on sensors specifications (Options)

Clamp-on sensor	CLAMP ON SENSOR 9694	CLAMP ON SENSOR 9660	CLAMP ON SENSOR 9661
Appearance			
Primary current rating	5A AC	100A AC	500A AC
Output voltage	10mV/A AC	AC 1mV/A AC	AC 1mV/A AC
Measurement range		See input specifications	
Amplitude accuracy *	±0.3%rdg.±0.02%f.s. *	±0.3%rdg.±0.02%f.s. *	±0.3%rdg.±0.01%f.s *
Phase accuracy *	±2° or less *	±1° or less *	±0.5° or less *
Maximum allowable input *	50 A continuous *	130 A continuous *	550 A continuous *
Maximum rated voltage to earth	CAT III 3	300Vrms	CAT III 600 Vrms
Frequency characteristics	±1.0% or l	ess for 66Hz to 5kHz (deviation from spe	cified accuracy)
Cord length	3m (9.84ft)		
Measurable conductor diameter	Max.ф15n	nm (0.59")	Max. 46mm (1.81")
Dimensions, Mass	46W(1.81")×135H(5. 230g(	31")×21D(0.83")mm,	78W(3.07")×152H(5.98")×42D(1.65")mm, 380g(13.4oz.)

Clamp-on sensor	CLAMP ON SENSOR 9669	FLEXIBLE CLAMP ON SENSOR CT9667
Appearance		
Primary current rating	1000 A AC	500A AC, 5000A AC
Output voltage	0.5mV/A AC	500 mV AC f.s.
Measurement range	See input	specifications
Amplitude accuracy *	±1.0%rdg.±0.01%f.s. *	±2.0%rdg.±0.3%f.s. *
Phase accuracy *	±1° or less *	±1° or less *
Maximum allowable input *	1000 A continuous *	10000 A continuous *
Maximum rated voltage to earth	CATIII 600Vrms	CATIII 1000 Vrms CATIV 600 Vrms
Frequency characteristics	Within ±2% at 40Hz to 5kHz (deviation from accuracy)	±3dB or less for 10 Hz to 20kHz (within ±3dB)
Cord length	3m (9.84ft)	Sensor to circuit: 2m (6.56ft) Circuit to connector: 1m (3.28ft)
Measurable conductor diameter	Max. $\phi$ 55 mm(2.17"), 80 (3.15")×20(0.79") mm busbar	Max. φ254mm(10")
Dimensions, Mass	99.5W (3.92") × 188H (7.40") × 42D (1.65") mm, 590g (20.8 oz.)	Circuit box: 35W (1.38") × 120.5H (4.74") × 34D (1.34") mm, 140 g (4.9 oz.)
Power supply	_	LR6 alkaline battery x2, AC Adapter (option) or external 5 to 15 V DC power supply
Options (sold separately)		AC ADAPTER 9445-02 (universal 100 to 240VAC, 9V/1A output/for USA) AC ADAPTER 9445-03 (universal 100 to 240VAC, 9V/1A output/for Europe)

Clamp-on sensor	CLAMP ON SENSOR 9695-02	CLAMP ON SENSOR 9695-03		
Appearance				
Primary current rating	50A AC	100A AC		
Output voltage	10mV/A AC	1mV/A AC		
Measurement range	See input sp	pecifications		
Amplitude accuracy *	±0.3%rdg.±0.02%f.s. *	±0.3%rdg.±0.02%f.s. *		
Phase accuracy *	Within ±2° *	Within ±1° *		
Maximum allowable input *	130 A continuous *	130 A continuous *		
Maximum rated voltage to earth	CATIII 300Vrms (in	sulated conductor)		
Frequency characteristic	Within ±2% at 40Hz to 5kH	Iz (deviation from accuracy)		
Cord length	CONNECTION CORD 9219	(sold separately) is required.		
Measurable conductor diameter	Max. φ15r	mm(0.59")		
Dimensions, Mass	51W(2.01")×58H(2.28")×1	9D(0.75")mm, 50g(1.8oz.)		
Options (sold separately)	CONNECTION CORD 9219 (Cord length:3m (9.84ft)			

Note: CONNECTION CORD 9219 (sold separately) is required.
\*: 45 to 66Hz



Clamp-on AC/DC sensor	AC/DC CLAMP ON SENSOR CT9691-90 (CT9691 bundled with the CT6590)	AC/DC CLAMP ON SENSOR CT9692-90 (CT9692 bundled with the CT6590)	AC/DC CLAMP ON SENSOR CT9693-90 (CT9693 bundled with the CT6590)
Appearance			
Includes	CT9691 ×1, CT6590 ×1	CT9692 ×1, CT6590 ×1	CT9693 ×1, CT6590 ×1
CT9691,CT9692,CT9693 (Clamp	sensor) specifications	-	
	CT9691 (3)	CT9692 O	СТ9693
Primary current rating	100A AC/DC	200A AC/DC	2000A AC/DC
Maximum input range (RMS value)	100Arms continuous*	200Arms continuous*	2000Arms continuous*
Maximum rated voltage to earth		CAT III AC/DC 600V	
Frequency band	DC to 10 kHz (-3dB)	DC to 20 kHz (-3dB)	DC to 15 kHz (-3dB)
Cord length	( 2 2 )	2m (6.5 ft)	( 3 )
Measurable conductor diameter	35 mm (1.38") or less	33 mm (1.30") or less	55 mm (2.17") or less
Dimensions, Mass	53W(2.09") × 129H(5.08") × 18D(0.71") mm, 230g (8.1 oz.)	62W( 2.44") × 167H(6.57") × 35D(1.38") mm, 410g (14.5 oz.)	62W(2.44") × 196H( 7.72") × 35D(1.38") mm, 500g (17.6 oz.)
CT6590 (SENSOR UNIT) specifications			
	CT6590		
Range when combined with sensor (H/L selectable)	H range: 100A AC/DC f.s. L range: 10A AC/DC f.s.	H range : 200A AC/DC f.s. L range : 20A AC/DC f.s.	H range: 2000A AC/DC f.s. L range: 200A AC/DC f.s.
Sensor combination Output rate	H range: 1mV/A L range: 10mV/A	H range: 1mV/A L range: 10mV/A	H range: 0.1mV/A L range: 1mV/A
Sensor combination measurement range		See input specifications	
Sensor combination accuracy (Continuous input)	±1.5%rdg.±1.0%f.s. (DC ≤ f ≤ 66 Hz)	±1.5%rdg.±0.5%f.s. (DC ≤ f ≤ 66 Hz)	±2.0%rdg.±0.5%f.s. (DC) ±1.5%rdg.±0.5%f.s. (45 ≤ f ≤ 66Hz, l ≤ 1800A) ±2.5%rdg.±0.5%f.s. (45 ≤ f ≤ 66Hz, 1800A <l 2000a)<="" td="" ≤=""></l>
Sensor combination accuracy (Phase)	±2deg. (DC < f ≤ 66 Hz)	±2deg. (DC < f ≤ 66 Hz)	±2deg. (45Hz ≤ f ≤ 66 Hz)
Cord length		1m (3.3ft)	1
Dimensions, Mass	36W(1.42") x 120H(4.72") x 34D(1.34") mm (excluding protruding parts), 165g(5.8 oz.) (including batteries)		
Diffierisions, iviass	LR6 alkaline battery x2, optional AC adapter, or 5 V to 15 VDC external power		
Power supply	LR6 alkaline ba	ttery x2, optional AC adapter, or 5 V to 15	VDC external power

Clamp-on leak sensor	CLAMP ON LEAK SENSOR 9657-10	CLAMP ON LEAK SENSOR 9675
Appearance		
Primary current rating	10A AC (Up to 5A	on Model PW3198)
Output voltage	100 m <sup>1</sup>	V/A AC
Measurement range	See input specifications (Canr	not be used to measure power)
Amplitude accuracy *	±1.0%rdg.±0.05%f.s. *	±1.0%rdg.±0.005%f.s. *
Residual current characteristics	Max. 5mA (in 100A go and return electric wire)	Max. 1mA (in 10A go and return electric wire)
Effect of external magnetic fields	400A AC/m correspond	ds to 5mA, Max. 7.5mA
Maximum rated voltage to earth	CATIII 300Vrms (in	sulated conductor)
Cord length	3m (9.84ft)	
Measurable conductor diameter	Max. φ40 mm(1.57")	Max. φ30 mm(1.18oz")
Dimensions, Mass	74W(2.91")×145H(5.71")× 42D(1.65)mm, 380g(13.4oz.)	60W(2.36")×112.5H(4.43")× 23.6D(23.6")mm, 160g(5.6oz.)

<sup>\*: 45</sup> to 66Hz

CLAMP ON SENSOR (Load current, AC)



**9661** 500A AC, φ46mm(1.81")



CT9667 500A AC/ 5000A AC (selectable), φ254mm (10"),

Power supply: LR06 alkaline battery or AC ADAPTER 9445-02/03 (sold separately)



CT9691-90 100A ACDC / 10A ACDC (selectable). φ35mm(1.38") Power supply: LR6 alkaline battery

or AC ADAPTER 9445-02/03 or AC ADAPTER 9445-02/03 (sold separately)



CT9692-90 200A ACDC / 20A ACDC (selectable). ф33mm(1.30") Power supply: LR6 alkaline battery



CT9693-90 2000A ACDC / 200A ACDC (selectable) φ55mm(2.17") Power supply: LR6 alkaline battery or AC ADAPTER 9445-02/03 (sold separately)

The CT9691-90, CT9692-90, and CT9693-90 represent the respective clamp sensor bundled with the CT6590 Sensor Unit.



9695-02 (50A AC)

9695-03 (100A AC)

**9694** 5A AC, φ15mm(0.59")

**9660** 100A AC, φ15mm(0.59")



**9669** 1000A AC, φ55mm(2.17"),

CONNECTION CORD 9219

For connecting 9695-02,9695-03 Cord length: 3m(9.84ft)





φ55mm(2.17") 80(3.15")×20(0.79")mm busbar, Cord length: 3m(9.84ft)

CLAMP ON LEAK SENSOR (Leak Current)



9657-10 10A AC (Up to 5A on Model PW3198), φ40mm(1.57"),



9675 10A AC(Up to 5A on Model PW3198), φ30mm(1.18"),

9219 is required (sold separately)

φ15mm(0.59"), CONNECTION CORD



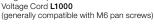
WIRING ADAPTER PW9000 For 3P3W WIRING



WIRING ADAPTER PW9001 For 3P4W WIRING



MAGNETIC ADAPTER 9804-01 (red) MAGNETIC ADAPTER 9804-02 (black) Magnetic tip for use with the standard

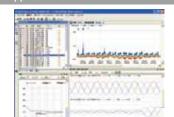


Red and black adapters sold separately. Purchase the quantity and color appropriate for your application.
(Example: 3P3W - 3 adapters; 3P4W - 4 adapters)



GRABBER CLIP 9243

For use with the standard Voltage Cord L1000



PQA-HiVIEW PRO 9624-50

Use Model 9624-50 PQA-HiVIEW PRO (version 2.00 or later) with a PC to analyze the data collected by the PW3198.



Reduce voltage cords for easy wiring

**CARRYING CASE** C1001

Soft case 450W× 345W× 210Dmm (17.7"W× 13.6"H× 8.3"D) 3.4kg (120oz.)



**CARRYING CASE** C1002

Hard case 413W× 595W× 265Dmm (16.3"W× 23.4"H× 10.4"D) 5.7kg (201oz.)



POWER QUALITY ANALYZER PW3198 Bundled accessories)

SD MEMORY CARD 2GB Z4001 VOLTAGE CORD L1000, AC ADAPTER Z1002 BATTERY PACK Z1003, Instruction manual Measurement guide, Strap, USB cable (Approx. 1m in length)

### POWER QUALITY ANALYZER PW3198-90

(Set with PQA HiVIEW PRO 9624-50 and bundled accessories)

Use Model PQA-HiVIEW PRO 9624-50 (version 2.00 or later) with a PC to analyze the data collected by the PW3198.





#### Voltage Cord L1000

8 cords, approx. 3 m each: 1 each red, yellow, blue, and gray plus 4 black: 8 alligator clips: 1 each red, yellow, blue, and gray plus 4 black



AC ADAPTER Z1002

ower supply for the PW3198 100V AC to 240V AC



SD MEMORY CARD 2GB Z4001

**IMPORTANT** Use only the SD Card Z4001 sold by HIOKI.



## ●Combination example: For three-phase 4-wire circuits containing leak current

PW3198-90 POWER QUALITY ANALYZER PW3198 set with PQA HIVIEW PRO 9624-50

 $9661 \times 3$ **CLAMP ON SENSOR (500A)** 

9675 CLAMP ON LEAK SENSOR PW9001

Note: Company names and Product names appearing in this catalog are trademarks or registered trademarks of various companies.

C1001 WIRING ADAPTER CARRYING CASE



GPS BOX PW9005
To synchronize the PW3198 clock,

Accessory: Connection cable set

HIOKI (Shanghai) SALES & TRADING CO., LTD.: TEL +86-21-63910090 FAX +86-21-63910360 http://www.hioki.cn / E-mail: info@hioki.com.cn

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